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EMC/EMI Test Report

Tested Product:
CAM230

Test Report TR-0634371_R1

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REVISION HISTORY

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1 INTRODUCTION

This test report describes EMC tests on the product CAM230:

- in compliance with electromagnetic compatibility directive 2014/30/EU as part of the requirements leading to the CE marking
- in compliance with the Electromagnetic Compatibility Regulations 2016 No. 1091 as part of the requirements leading to the UKCA marking
- in compliance with FCC part 15 subpart B
- in compliance with ICES-003

The essential requirements of the directive 2014/30/EU and the Electromagnetic Compatibility Regulations 2016 No. 1091 are covered by the following harmonized standards:

- EN 55032 (2015) A11 (2020) – *Electromagnetic compatibility of multimedia equipment - Emission requirements*
- EN 55035 (2017) A11 (2020) – *Electromagnetic compatibility of multimedia equipment – Immunity requirements*

2 ACRONYMS

EMC: ElectroMagnetic Compatibility

EUT: Equipment Under Test

S/N: Serial Number

N/A: Not Applicable / Not Available

NCR: No Calibration Required

VERIF: Internal Verification of Equipment Characteristics

AC: Alternating Current

DC: Direct Current

PSU: Power Supply Unit

LISN: Line Impedance Stabilisation Network

AM: Amplitude Modulation

CDN: Coupling/Decoupling Network

EM Clamp: Electromagnetic Clamp

I/O: Inputs/Outputs

PE: Protective Earth

HCP: Horizontal Coupling Plane

VCP: Vertical Coupling Plane

ESD: Electrostatic Discharge

EFT: Electrical Fast Transient

Pst: short-term flicker

Plt: long-term flicker

Un: Nominal Voltage

3 PROJECT DATES

RECEPTION DATE(S)
(yyyy-mm-dd) 2023-04-05 (LABCEM#3464)

TESTS DATE(S)
(yyyy-mm-dd) From 2023-04-05 to 2023-04-10 (LABCEM#3464)

4 DESCRIPTION OF EQUIPMENT UNDER TEST

4.1 EUT

TYPE:	Camera selector
PRODUCT NAME:	CAM230
MANUFACTURER:	Inogeni
LABCEM NUMBER:	LABCEM#3464
PART NUMBER:	CAM230
SERIAL NUMBER:	KUO3090013
VOLTAGE RATING:	12Vdc
EXTERNAL PSU INFO:	Manufacturer: Phihong Model: ICP20-120-1200D P/N: ICP20-120-1200D S/N: N/A Input Voltage: 100-240V, 50-60Hz Output Voltage: 12Vdc
EUT SIZE:	Width = 17cm Height = 4cm Depth = 12cm
FIRMWARE:	Original: 1.23 After modification: 1.23C
HIGHEST INTERNAL FREQUENCY:	1.5GHz



Photo 1: EUT



Photo 2: EUT S/N

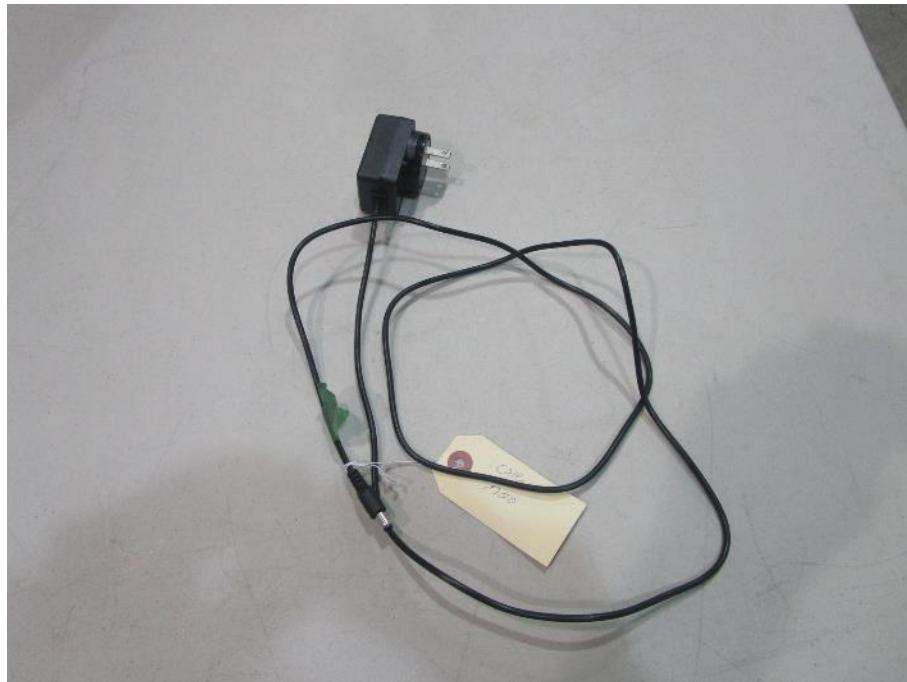


Photo 3: PSU



Photo 4: PSU – S/N

4.2 Support Equipment

EUT was exercised with support equipment supplied by client.



Photo 5: Support Equipment - Laptop



Photo 6: Support Equipment - Monitor



Photo 7: Support Equipment – Video pattern generator



Photo 8: Support Equipment – Ethernet switch



Photo 9: Support Equipment – USB router



Photo 10: Support Equipment – USB 3.0 Camera



Photo 11: Support Equipment – USB 2.0 Camera

4.3 EUT Setup Diagram

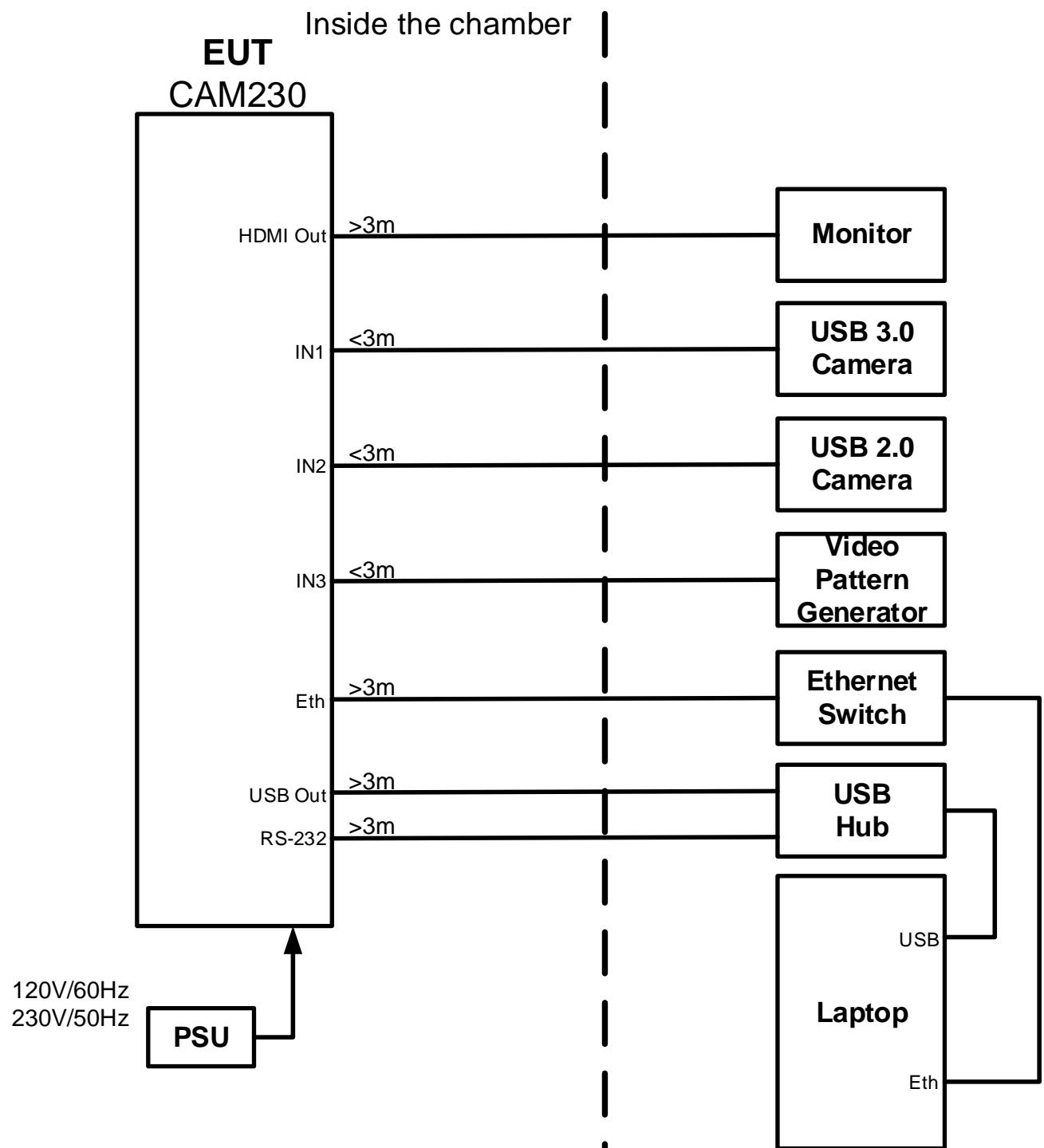
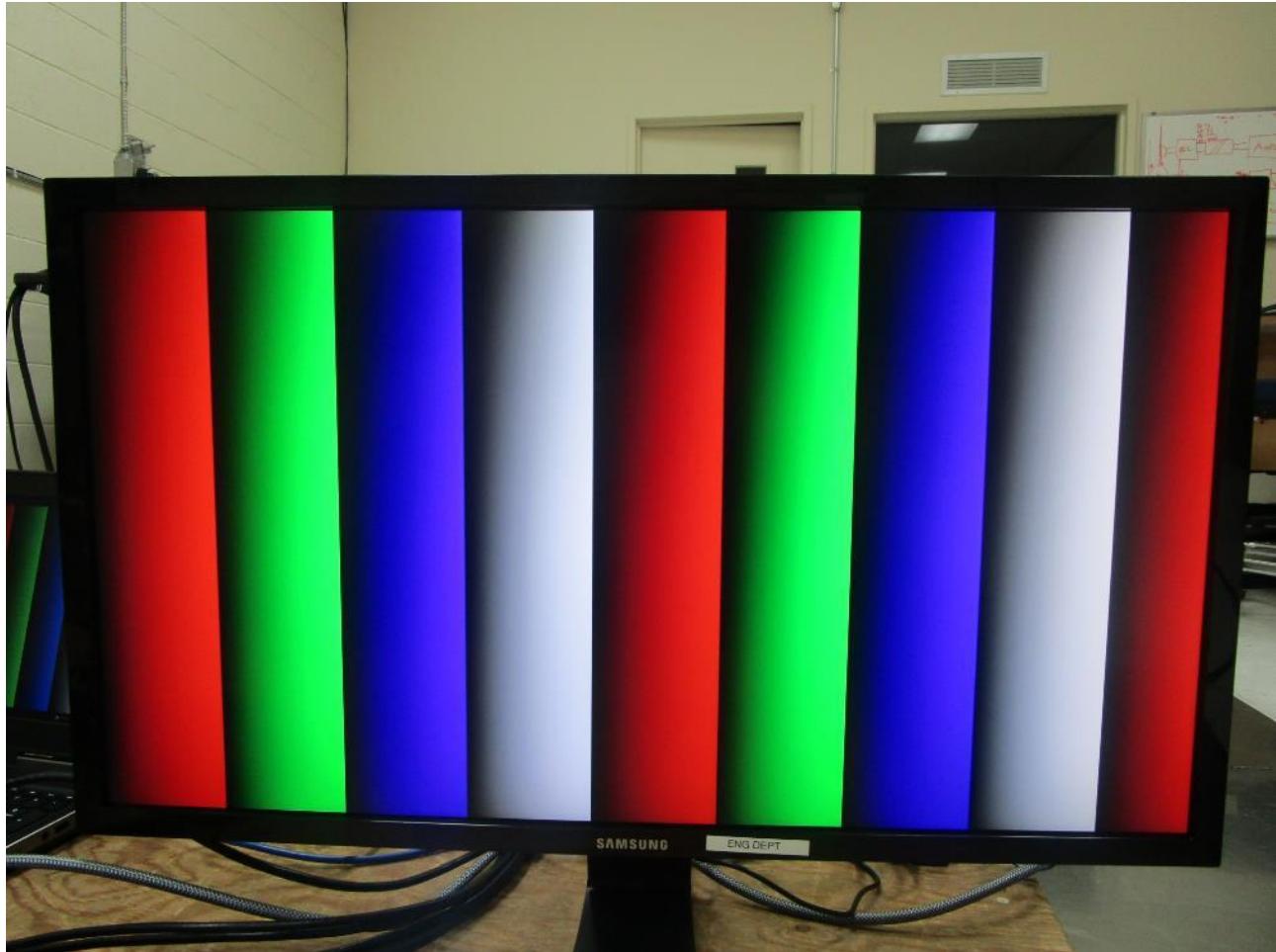


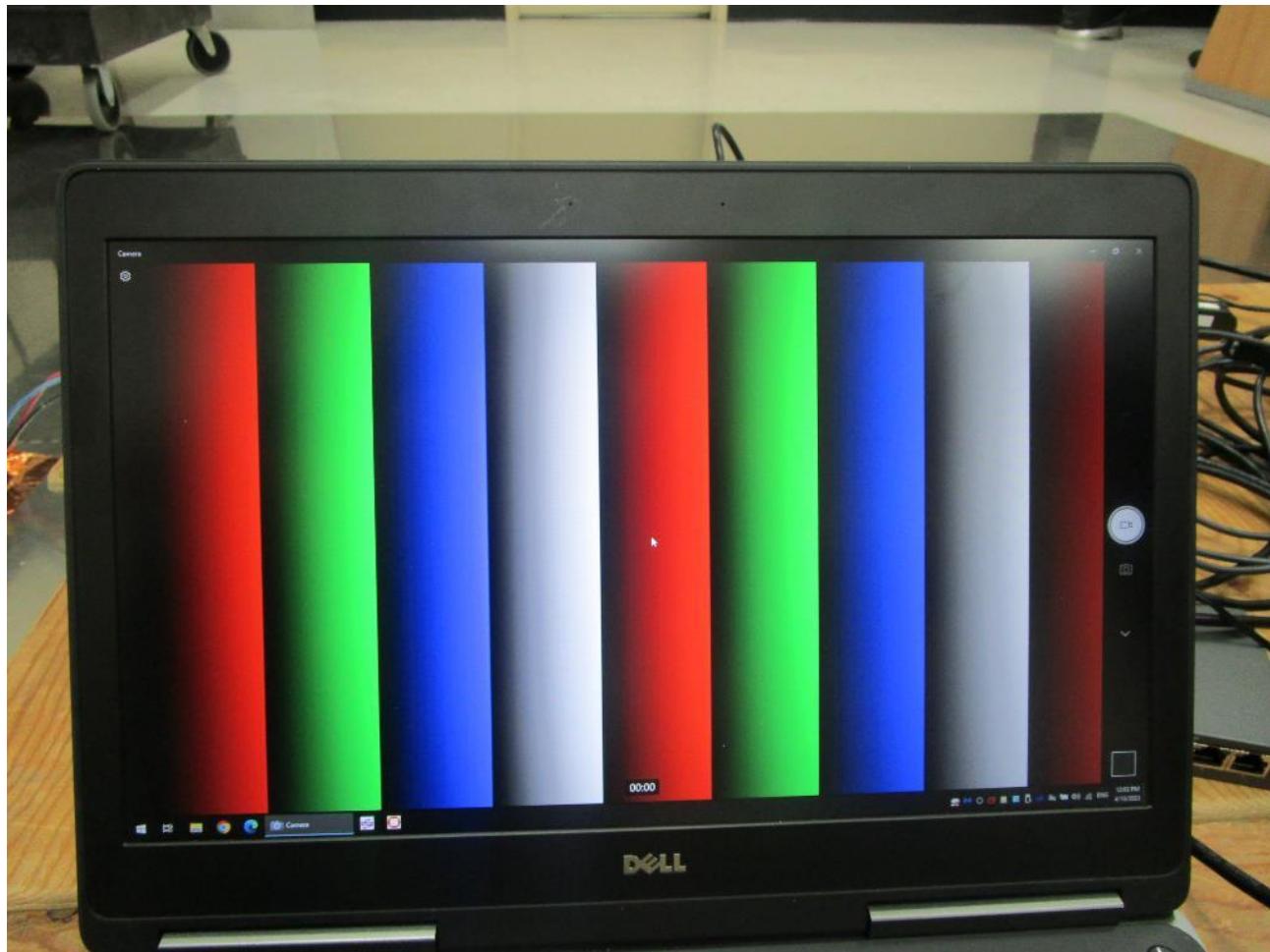
Figure 1: EUT Setup Diagram

4.4 Mode of Operation

During the tests, the EUT was exercised by powering it to 230V/50Hz or 120V/60Hz. A video signal was applied to IN1, IN2 and IN3. The signal on IN3, from the video pattern generator, was routed to HDMI out which was connected to a monitor, and also to the laptop via USB. The Ethernet port was connected to the laptop Ethernet port via an Ethernet switch. The Ethernet switch was providing power to the CAM230 via Power Over Ethernet. The EUT was prioritizing the power from the main power port. If no power was available on the main power port, then the EUT was automatically switching to POE.



Capture 1: Client Software - Monitor



Capture 2: Client Software - Laptop

4.5 Method of Monitoring

During the tests, the EUT was monitored by observing the video pattern on the laptop and on the monitor.

5 PERFORMANCE CRITERIA

During the tests, EUT shall operate normally and the picture on the laptop and the display shall remain stable.

The performance criteria for the evaluation of the immunity test results are defined by EN 55035 standard (Electromagnetic compatibility of multimedia equipment – Immunity requirements).

Performance criterion A: The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion B: During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test.

After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion C: Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

6 CALCULATION OF THE COMPLIANCE MARGIN

Conducted Emission Level (dB μ V) =	Value Reading at the EMI receiver (dB μ V) + Correction Factor (dB)
Correction Factor (dB) =	LISN Attenuation (dB) + Cable Loss (dB) – Amplifier Gain (dB) + Attenuator (dB)
Margin (dB) =	Conducted Emission Level (dB μ V) – Limit Value (dB μ V)

Table 1: Example of Conducted Emissions Margin Calculation

Radiated Emission Level (dB μ V/m) =	Value reading at the EMI receiver (dB μ V) + Antenna Factor (dB/m) + Correction Factor (dB)
Correction Factor (dB) =	Cable Loss (dB) – Amplifier Gain (dB) + Attenuator (dB)
Margin (dB) =	Radiated Emission Level (dB μ V/m) – Limit Value (dB μ V/m)

Table 2: Example of Radiated Emissions Margin Calculation

7 MEASUREMENT UNCERTAINTIES

All measurements under compliance testing, involve certain levels of uncertainties based on test equipment and facilities. The measurement uncertainties of National Technical Systems Canada Inc. (U_{LAB}) were calculated according to CISPR16-4-2 standard and were lower than the maximum allowed by the standard (U_{CISPR}). Therefore, the measurement uncertainties need not to be considered for compliance.

The following table presents uncertainty calculation for emission measurements as requested by ANSI C63.4 (2014):

Test	Expanded Uncertainty with k=2 Coverage Factor (95% Confidence Level)
Conducted Emissions with LISN (9kHz-150kHz)	± 3.77 dB
Conducted Emissions with LISN (150kHz-30MHz)	± 3.33 dB
Radiated Emissions (30MHz-1GHz)	± 5.87 dB
Radiated Emissions (1GHz-18GHz)	± 5.10 dB

Table 3: Measurement Uncertainties

All other calculations of uncertainties evaluation are available upon request.

8 ENGINEERING COMMENTS

8.1 Modifications incorporated in the EUT

2023-04-06 – Modification #1 on EUT (LABCEM#3464)

In order to be compliant with electrostatic discharge test, the firmware has been modified to wait a delay before changing the selected input after losing the video signal from this input. If the signal comes back within that delay, the EUT won't switch to another input. The old firmware version was 1.23. The new was 1.23C.

No other modification was performed on the EUT during testing.

8.2 Deviations from the standards and/or laboratory tests procedure

No deviation from standards and/or test laboratory procedure was performed during testing.

9 TEST SUMMARY

The following table lists all tests called by the harmonized standards indicated in the test report introduction.

Test Name Standards	Test Specifications	Minimum Performance Criterion Required	EUT Serial Number	Results
Conducted Emissions FCC part 15 subpart B (2022)	Class A 150kHz-30MHz	N/A	KUO3090013	Pass
Radiated Emissions FCC part 15 subpart B (2022)	Class A 30MHz-1GHz	N/A	KUO3090013	Pass
Conducted Emissions ICES-003 Issue 7 (2020)	Class A 150kHz-30MHz	N/A	KUO3090013	Pass
Radiated Emissions ICES-003 Issue 7 (2020)	Class A 30MHz-1GHz	N/A	KUO3090013	Pass
Conducted Emissions EN 55032 (2015) A11 (2020)	Class A 150kHz-30MHz	N/A	KUO3090013	Pass
Radiated Emissions EN 55032 (2015) A11 (2020)	Class A 30MHz-1GHz	N/A	KUO3090013	Pass
Harmonic Current Emission Limits EN IEC 61000-3-2 (2019) A1 (2021)	Class A	N/A	KUO3090013 w/ modification #1	Pass
Voltage Fluctuations and Flicker Limitations EN 61000-3-3 (2013) A1 (2019) A2 (2021)	Observation period for P _{st} : 10 min Observation period for P _{lt} : 120 min	N/A	KUO3090013 w/ modification #1	Pass
Electrostatic Discharge Immunity IEC 61000-4-2 (2008)	Contact: ±4kV Air: ±2kV, ±4kV, ±8kV	B	KUO3090013 w/ modification #1	Pass
Radiated Electromagnetic Field Immunity IEC 61000-4-3 (2020)	80MHz-1000MHz: 3V/m 1.8GHz, 2.6GHz: 3V/m 3.5GHz, 5GHz: 3V/m	A	KUO3090013 w/ modification #1	Pass
Electrical Fast Transient Immunity IEC 61000-4-4 (2012)	Power: ±1kV / 5kHz I/O Ports: ±0.5kV / 5kHz Communication Ports: ±0.5kV / 5kHz	B	KUO3090013 w/ modification #1	Pass
Surge Immunity IEC 61000-4-5 (2014) A1 (2017)	Power: ±2kV L-PE / ±1kV L-L I/O Ports: N/A Communication Ports: N/A	B	KUO3090013 w/ modification #1	Pass
Immunity to Conducted Disturbances, Induced by Radio-Frequency Fields IEC 61000-4-6 (2013)	Power: 3V I/O Ports: 3V Communication Ports: 3V	A	KUO3090013 w/ modification #1	Pass
Power Frequency Magnetic Field Immunity IEC 61000-4-8 (2009)	Continuous Field: 1A/m / 50Hz & 60Hz	A	KUO3090013 w/ modification #1	Pass

Test Name Standards	Test Specifications	Minimum Performance Criterion Required	EUT Serial Number	Results
Voltage Dips, Short Interruptions and Voltage Variation Immunity on AC Input IEC 61000-4-11 (2020)	<p>Voltage dips:</p> <ul style="list-style-type: none"> 0%Un during half cycle (at 60Hz) 70%Un during 25 cycles (at 50Hz) 70%Un during 30 cycles (at 60Hz) <p>Short interruptions:</p> <ul style="list-style-type: none"> 0%Un during 250 cycles (at 50Hz) 0%Un during 300 cycles (at 60Hz) 	B C C C C	KUO3090013 w/ modification #1	Pass

Table 4: Test Summary

10 EMISSIONS TESTS**10.1 Conducted Emissions****10.1.1 Test Details**

REFERENCE STANDARD	EN 55032 (2015) A11 (2020) ANSI C63.4 (2014)
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SPECIFICATIONS

Frequency Range	150kHz – 30MHz
Installation	Table-top equipment

EUT

Identification	CAM230
Voltage Input	230V/50Hz 120V/60Hz

TEST INFO

Test Date (yyyy-mm-dd)	2023-04-05
Temperature °C (For Info Only)	22.9°C
Relative humidity % (For Info Only)	16.7%
Atmospheric pressure kPa (For Info Only)	103kPa
Operator	Jean Cadotte
Client Witness	Louis-Sacha Constantineau (Inogeni)

10.1.2 Test Equipment

Manufacturer	Description	Model	Serial No	Calibration Cycle (month)	Next Calibration (y-m-d)
TDK	Emission Anechoic Chamber	16706-1	5412	24	2024-08-26 (NSA / SVSWR)
NEXIO	Software	BAT-EMC v2022.0.23.0	N/A	N/A	N/A
Rohde&Sch	EMI receiver	ESW44	101905	12	2024-01-26
NARDA	LISN	PMM L2-16B	000WX20801	12	2023-06-10
TESEQ	ISN, CDN	ST08A	33995	24	2024-10-05

Table 5: Conducted Emissions – Test Equipment

10.1.3 Test Results

Tested Line	Frequency (MHz)	Average Limit (dB μ V)	Quasi-Peak Limit (dB μ V)	Results
Power – Phase (230V/50Hz)	0.150 – 0.50	66	79	Pass
	0.50 – 30	60	73	
Power – Neutral (230V/50Hz)	0.150 – 0.50	66	79	Pass
	0.50 – 30	60	73	

The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client.

Table 6: Conducted Emissions – Test Results – EN55032 Class A

Tested Line	Frequency (MHz)	Average Limit (dB μ V)	Quasi-Peak Limit (dB μ V)	Results
Power – Phase (120V/60Hz)	0.150 – 0.50	66	79	Pass
	0.50 – 30	60	73	
Power – Neutral (120V/60Hz)	0.150 – 0.50	66	79	Pass
	0.50 – 30	60	73	

The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client.

Table 7: Conducted Emissions – Test Results – FCC Part 15 Subpart B / ICES-003 Class A

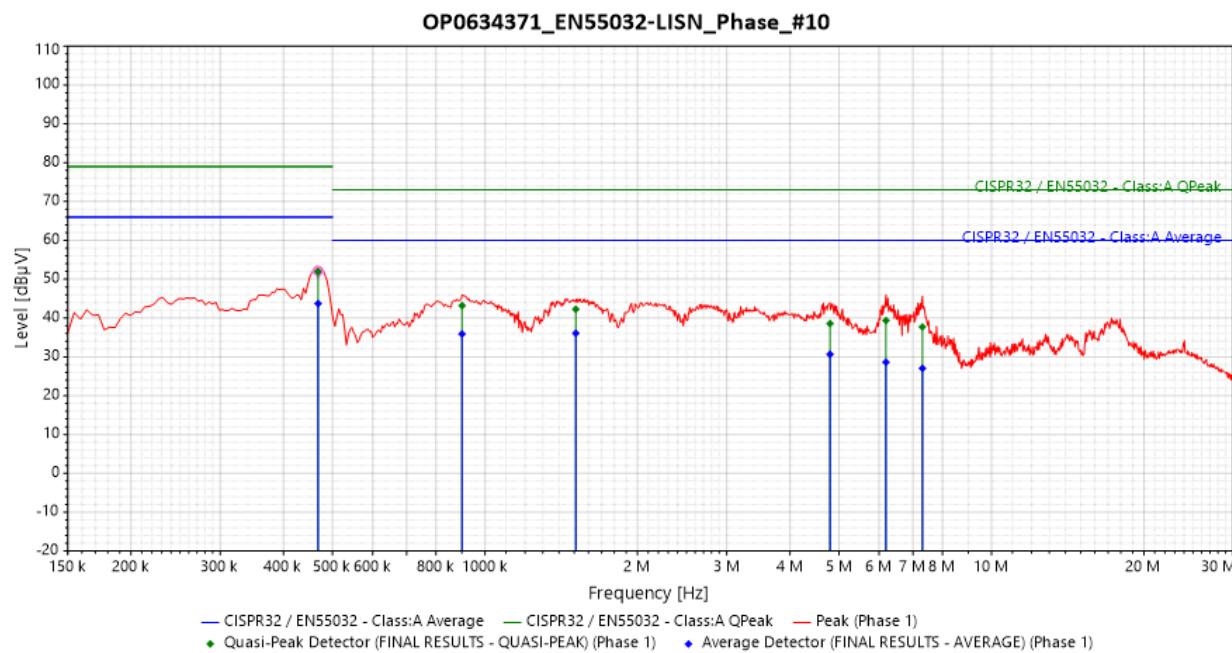
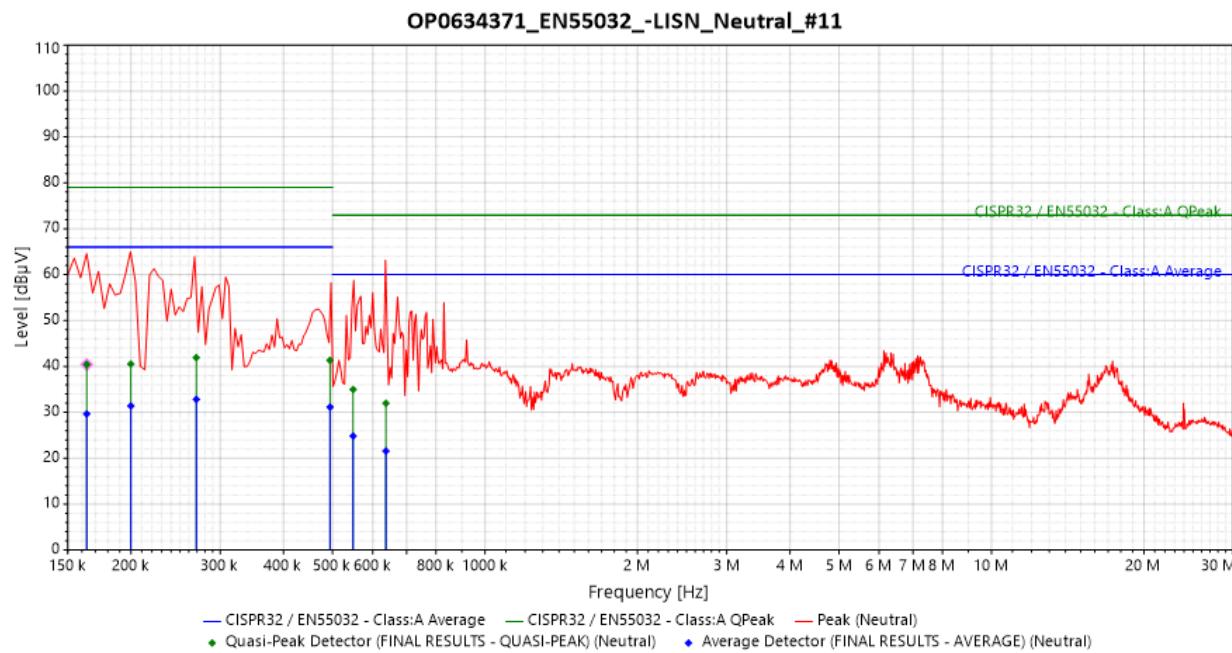
Tested Line	Frequency (MHz)	Average Limit (dB μ V)	Quasi-Peak Limit (dB μ V)	Results
Ethernet	0.150 – 0.50	84 to 74	97 to 87	Pass
	0.50 – 30	74	87	

The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client.

Table 8: Conducted Emissions – Test Results – EN55032 Class A Telecom Ports

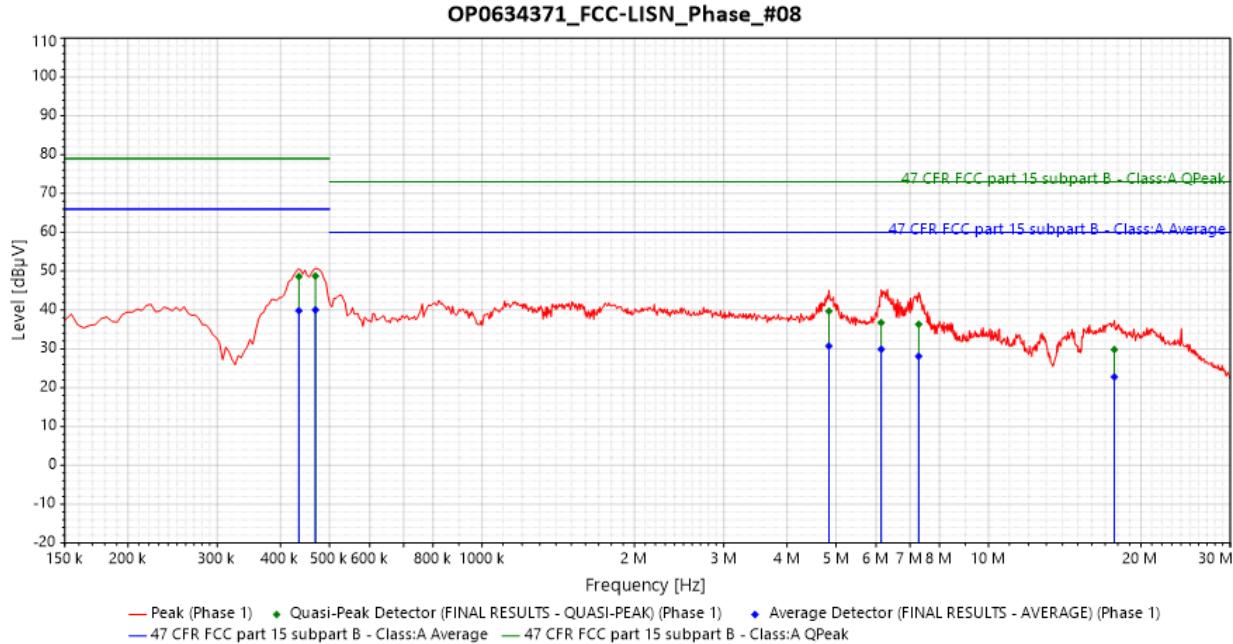
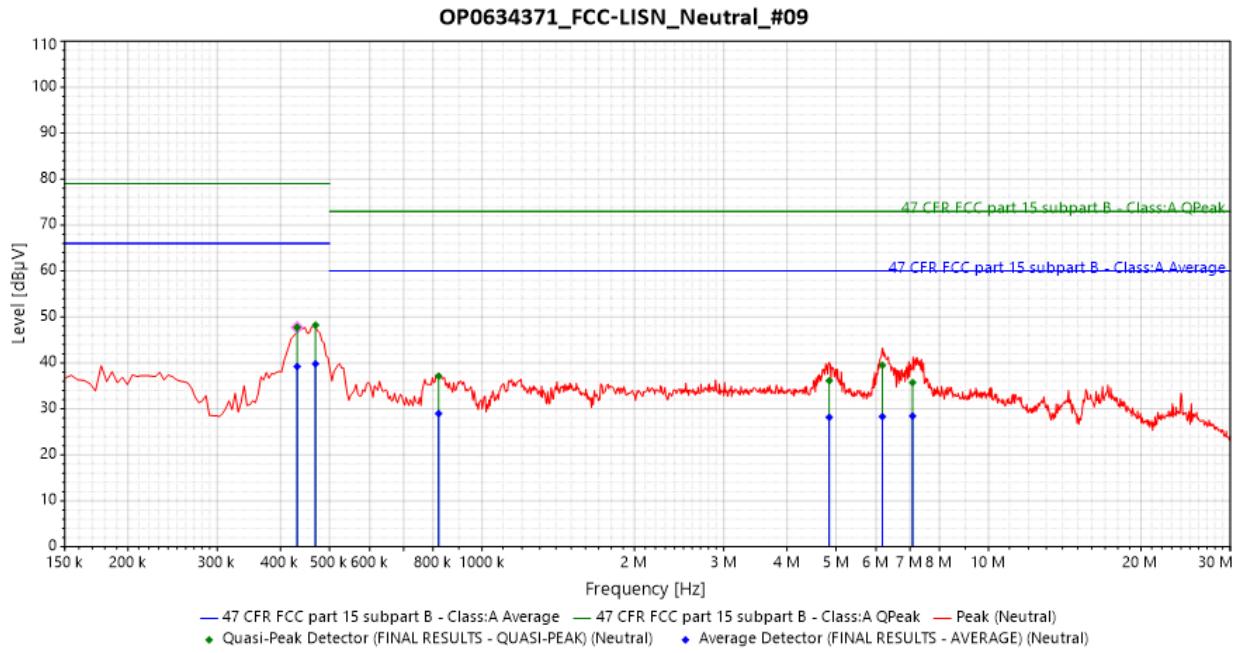
10.1.4 Test Data

See APPENDIX A for data files.

**Graph 1: Conducted Emissions – EN55032 – Power – Phase****Graph 2: Conducted Emissions – EN55032 – Power – Neutral**

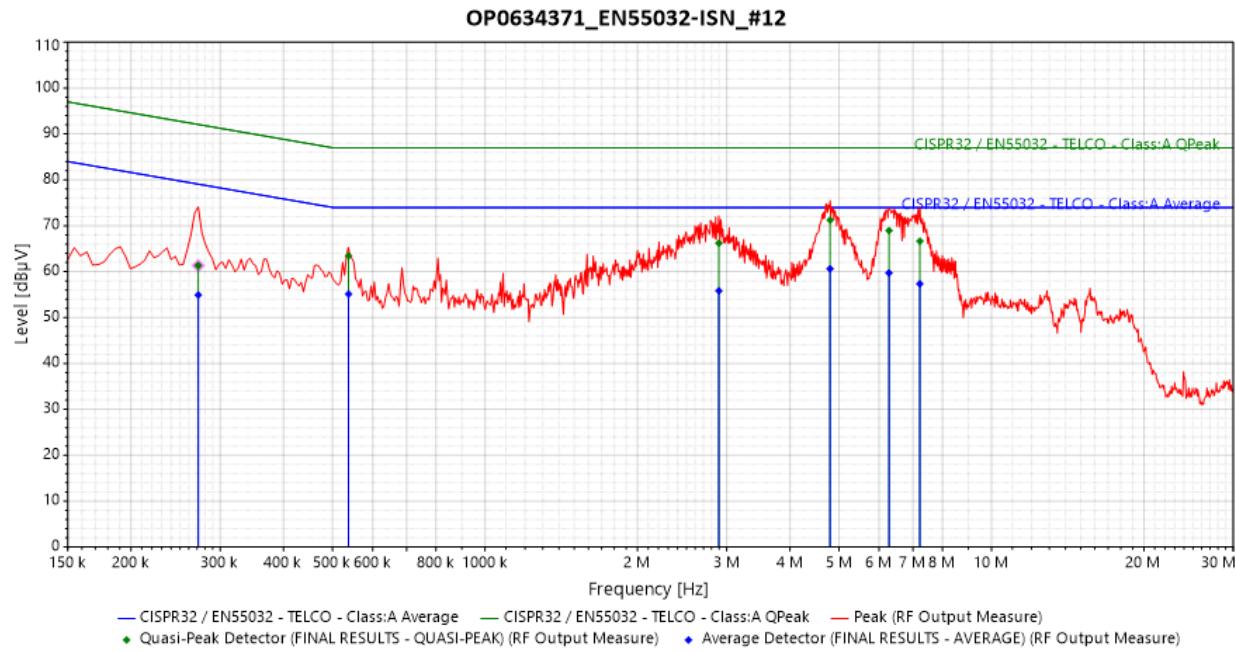
Tested Line	Frequency (MHz)	Detector	Level (dB μ V)	Limit (dB μ V)	Bandwidth (kHz)	Measurement Time (s)	Margin (dB)
Power – Phase (230V/50Hz)	0.4681	Average	43.732	66.000	9 kHz	15	22.268
Power – Neutral (230V/50Hz)	0.2691	Average	32.841	66.000	9 kHz	15	33.159

Table 9: Conducted Emissions – Lowest Margin according to EN55032.

**Graph 3: Conducted Emissions – FCC part 15 Subpart B – Power – Phase****Graph 4: Conducted Emissions – FCC part 15 Subpart B – Power – Neutral**

Tested Line	Frequency (MHz)	Detector	Level (dB μ V)	Limit (dB μ V)	Bandwidth (kHz)	Measurement Time (s)	Margin (dB)
Power – Phase (120V/60Hz)	0.4689	Average	40.014	66.000	9 kHz	15	25.986
Power – Neutral (120V/60Hz)	0.4691	Average	39.803	66.000	9 kHz	15	26.197

Table 10: Conducted Emissions – Lowest Margin according to FCC Part 15 Subpart B / ICES-003

**Graph 5: Conducted Emissions – EN55032 – Telecom Ports**

Tested Line	Frequency (MHz)	Detector	Level (dB μ V)	Limit (dB μ V)	Bandwidth (kHz)	Measurement Time (s)	Margin (dB)
Ethernet	4.8009	Average	60.625	74.000	9 kHz	15	13.375

Table 11: Conducted Emissions – Lowest Margin according to EN55032 – Telecom Ports

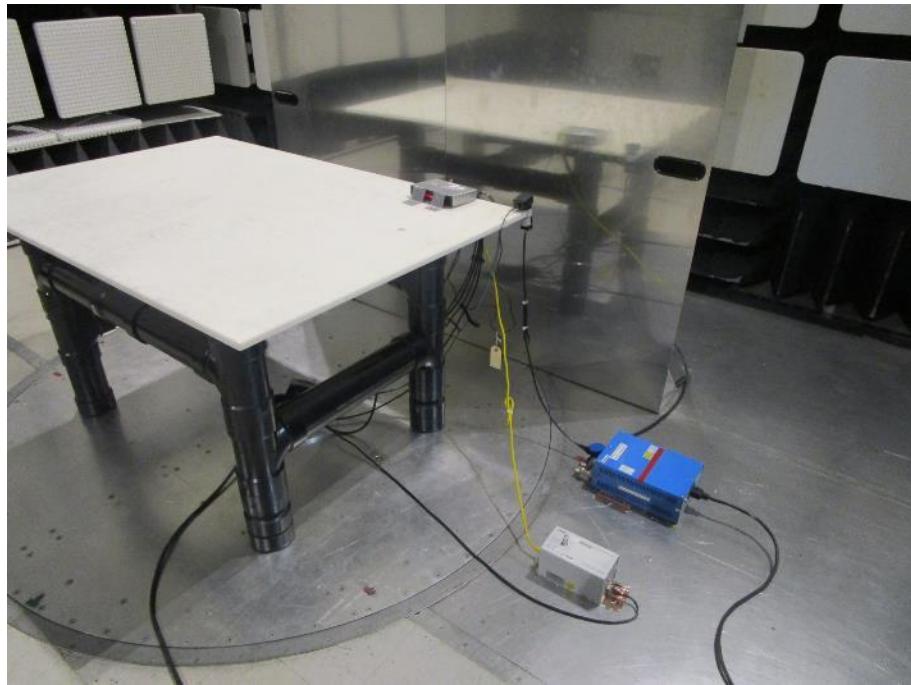


Photo 12: Conducted Emissions – Test Setup



Photo 13: Conducted Emissions – Telecom Ports – Test Setup

10.1.5 Test Method

Conducted emissions were performed using the procedures of the reference standard.

Once the configuration or mode of operation causing the highest emission level (worst case) was determined, a scan was performed with the Peak detector in the frequency range specified by the reference standard.

Frequencies where level was above the limit or within 20dB of the limit were recorded. The level at these frequencies was measured with the detector specified by the limit.

10.2 Radiated Emissions

10.2.1 Test Details

REFERENCE STANDARD	EN55032 (2015) A11 (2020) ANSI C63.4 (2014)
SPECIFICATIONS	
Limit	EN55032 (2015) A11 (2020) class A FCC part 15 subpart B (2022) class A ICES-003 Issue 7 (2020) class A
Frequency Range	30MHz – 1GHz 1GHz - 9GHz
Measurement Distance	3m
Installation	Table-top equipment
EUT	
Identification	CAM230
Voltage Input	230V/50Hz
TEST INFO	
Test Date (yyyy-mm-dd)	2023-04-05
Temperature °C (For Info Only)	22.9°C
Relative humidity % (For Info Only)	16.7%
Atmospheric pressure kPa (For Info Only)	103kPa
Operator	Jean Cadotte
Client Witness	Louis-Sacha Constantineau (Inogeni)

10.2.2 Test Equipment

Manufacturer	Description	Model	Serial No	Calibration Cycle (month)	Next Calibration (y-m-d)
TDK	Emission Anechoic Chamber	16706-1	5412	24	2024-08-26 (NSA / SVSWR)
Sunol Sciences Corporation	Antenna Positioning Tower	TLT2	LABCEM #0181	N.C.R.	N.C.R.
Sunol Sciences Corporation	Flush Mount Turntable	FM2011VS/2022VS	LABCEM #0182	N.C.R.	N.C.R.
Sunol Sciences Corporation	System Controller	SC110V	LABCEM #0183	N.C.R.	N.C.R.
NEXIO	Software	BAT-EMC v2022.0.23.0	N/A	N/A	N/A
Rohde&Schwarz	EMI receiver	ESW44	101905	12	2024-01-26
Schaffner	Bilog antenna	CBL6112D	22617	24	2023-06-28
TESEQ	Horn antenna	BHA9118	33053	24	2024-09-20
Amplical	Amplifier 1GHz-18GHz	AMP1G18-30-N/PSU	121212	12	2024-01-03

Table 12: Radiated Emissions – Test Equipment

10.2.3 Test Results

Frequency (MHz)	Quasi-Peak Limit extrapolated at 3m (dB μ V/m)	Average Limit at 3m (dB μ V/m)	Peak Limit at 3m (dB μ V/m)	Results
30 – 230	50	-	-	Pass
230 – 1000	57	-	-	
1000 – 3000	-	56	76	Pass
3000 – 6000	-	60	80	

The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client.

Table 13: Radiated Emissions – Test Results – EN55032 Class A

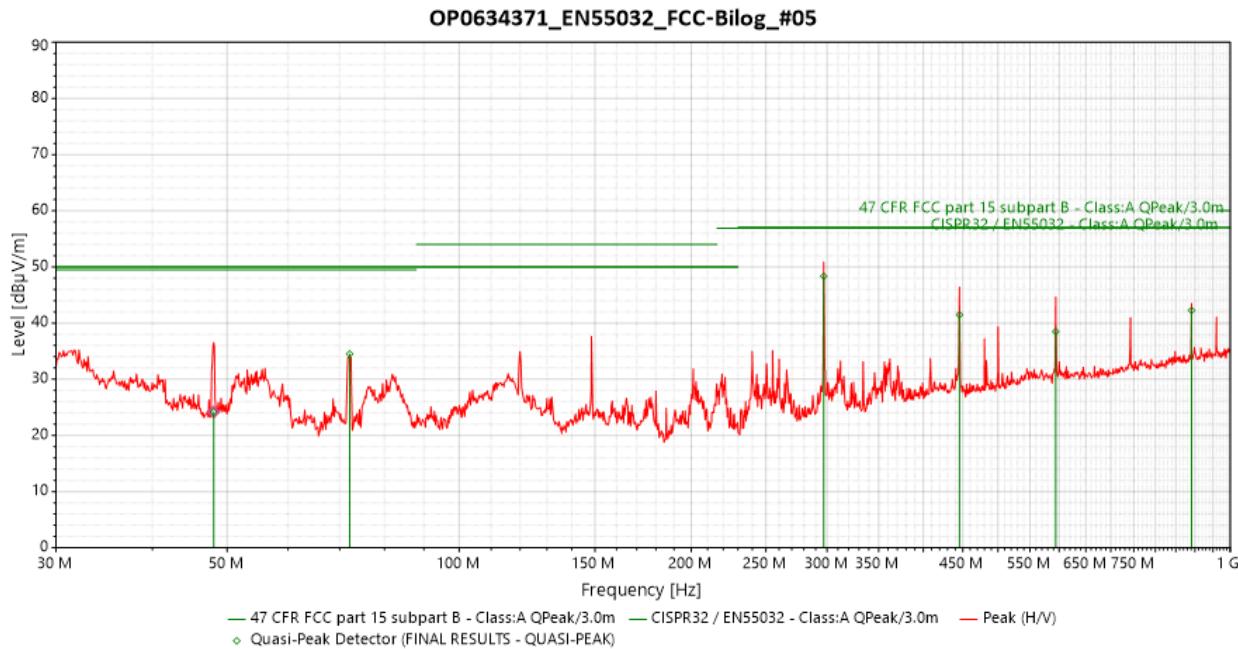
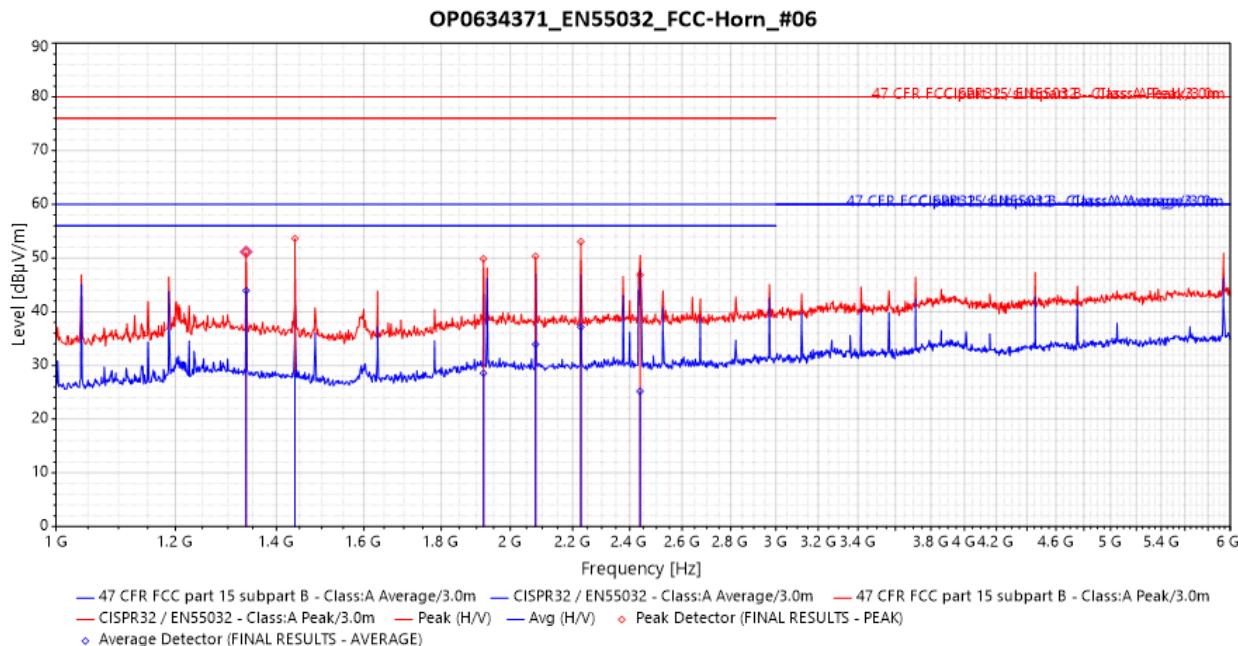
Frequency (MHz)	Quasi-Peak Limit extrapolated at 3m (dB μ V/m)	Average Limit at 3m (dB μ V/m)	Peak Limit at 3m (dB μ V/m)	Results
30 – 88	49.5	-	-	Pass
88 – 216	54.0	-	-	
216 – 960	56.9	-	-	
960 – 1000	60.0	-	-	
1000 – 9000	-	60	80	Pass

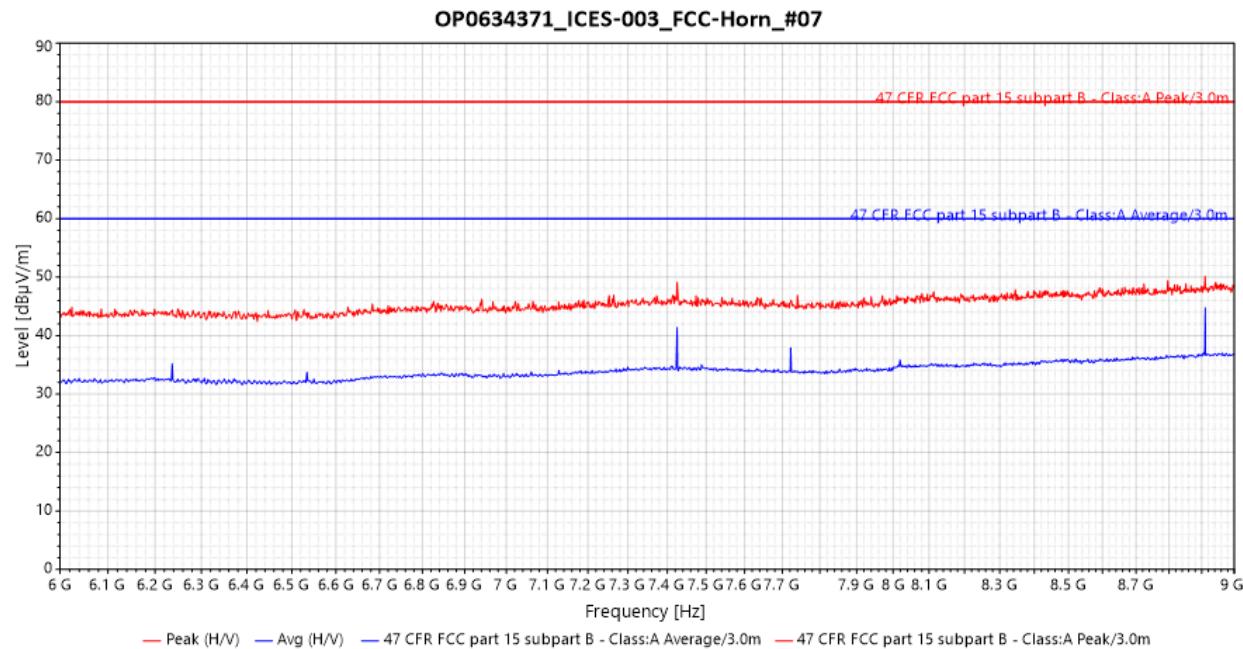
The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client.

Table 14: Radiated Emissions – Test Results – FCC Part 15 Subpart B / ICES-003 Class A

10.2.4 Test Data

See APPENDIX B for data files.

**Graph 6: Radiated Emissions 30MHz-1GHz****Graph 7: Radiated Emissions 1GHz-6GHz**



Graph 8: Radiated Emissions 6GHz-9GHz

Frequency (MHz)	Detector	Level (dB μ V/m)	Limit (dB μ V/m)	Bandwidth (kHz)	Measurement Time(s)	Margin (dB)
297.0135	Quasi-Peak	48.337	57.000	120	15	8.663
1336.5621	Average	43.929	56.000	1000	15	12.071

Table 15: Radiated Emissions – Lowest Margin according to EN55032

Frequency (MHz)	Detector	Level (dB μ V/m)	Limit (dB μ V/m)	Bandwidth (kHz)	Measurement Time(s)	Margin (dB)
297.0135	Quasi-Peak	48.337	56.900	120	15	8.763
1336.5621	Average	43.929	60.000	1000	15	15.171

Table 16: Radiated Emissions – Lowest Margin according to FCC Part 15 Subpart B / ICES-003

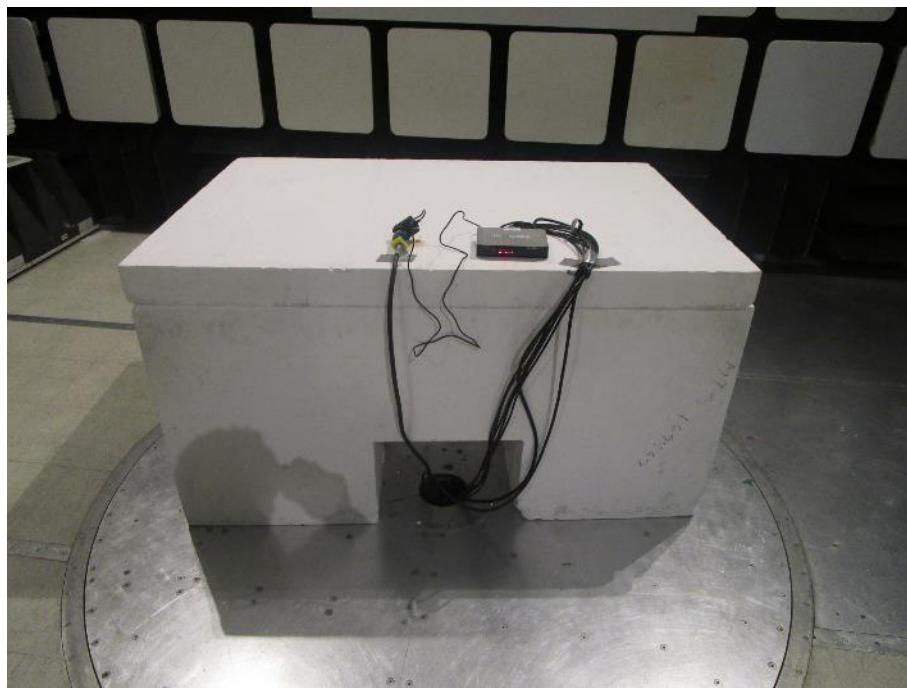


Photo 14: Radiated Emissions – Test Setup

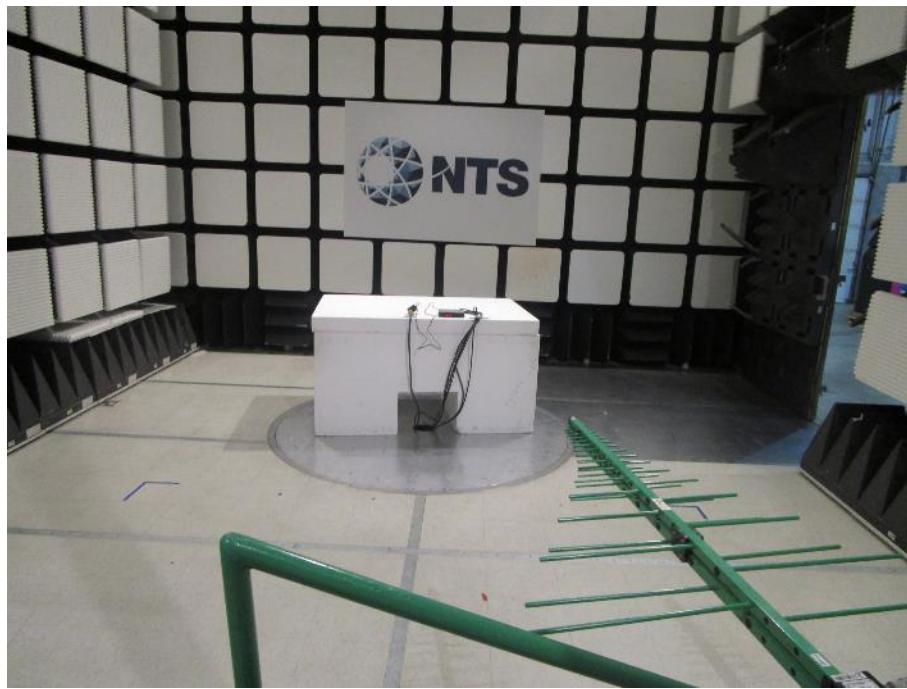


Photo 15: Radiated Emissions – Test Setup 30MHz-1GHz

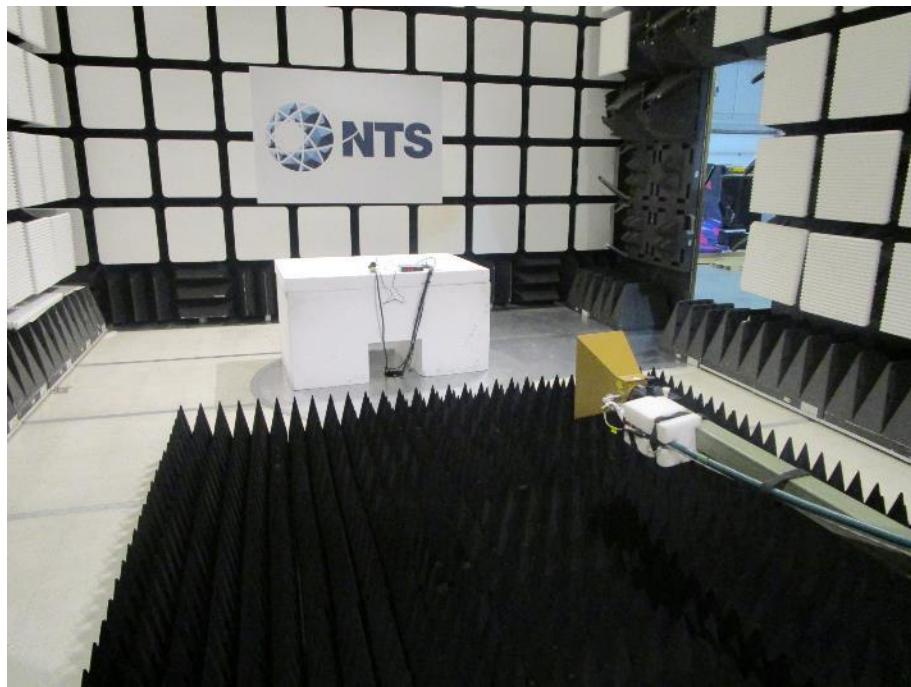


Photo 16: Radiated Emissions – Test Setup 1GHz-9GHz



Photo 17: Radiated Emissions – Support Equipment

10.2.5 Test Method

Radiated emissions were performed using the procedures of the reference standard.

Once the configuration or mode of operation causing the highest emission level (worst case) was determined, spectral previews were performed with the Peak detector in the frequency range specified by the reference standard.

Frequencies where level was above the limit or within 10 dB of the limit were recorded. The level at these frequencies was maximized and measured with the detector specified by the limit.

Note on FCC measurements combined with CISPR measurements for frequency above 1 GHz

Measurement methods of radiated emissions are slightly different between FCC regulation and CISPR standard. The FCC through ANSI C63.4 requires boresighting (tilt) and CISPR16-2-3 does not. For better efficiency, only the boresighting method is carried out, which may increase the level of disturbances during the final evaluation with the CISPR limit.

10.3 Harmonic Current Emissions

10.3.1 Test Details

REFERENCE STANDARD	EN IEC 61000-3-2 (2019) A1 (2021)
SPECIFICATIONS	
Limit	Class A
EUT	
Identification	CAM230
Voltage Input	230V/50Hz
TEST INFO	
Test Date (yyyy-mm-dd)	2023-04-06
Temperature °C (For Info Only)	23.2°C
Relative humidity % (For Info Only)	28.2%
Atmospheric pressure kPa (For Info Only)	101.6kPa
Operator	Jean Cadotte
Client Witness	No witness

10.3.2 Test Equipment

Manufacturer	Description	Model	Serial No	Calibration Cycle (month)	Next Calibration (y-m-d)
TESEQ	Software	Win2100 v4.9	N/A	N/A	N/A
TESEQ	AC-DC Power source	NSG 1007	1232A04499 (NSG 1007)	24	2023-09-14

Table 17: Harmonic Current Emissions – Test Equipment

10.3.3 Test Results

<input checked="" type="checkbox"/> Class A	<input type="checkbox"/> Class B	<input type="checkbox"/> Class C	<input type="checkbox"/> Class D
Class A:			
Equipment not specified as belonging to Class B, C or D shall be considered as Class A equipment.			
<ul style="list-style-type: none"> • balanced three-phase equipment; • household appliances, excluding those specified as belonging to Class B, C or D; • vacuum cleaners; • high pressure cleaners; • tools, excluding portable tools; • independent phase control dimmers; • audio equipment; • professional luminaires for stage lighting and studios. 			
NOTE 1 Equipment that can be shown to have a significant effect on the supply system may be reclassified in a future of this document, taking into account the following factors:			
<ul style="list-style-type: none"> – number of pieces of equipment in use; – duration of use; – simultaneity of use; – power consumption; – harmonic spectrum, including phase. 			
Class B:			
<ul style="list-style-type: none"> • portable tools; • arc welding equipment which is not professional equipment. 			
Class C:			
<ul style="list-style-type: none"> • lighting equipment. 			
Class D:			
Equipment having a specified power according to 6.3.2 less than or equal to 600 W, of the following types:			
<ul style="list-style-type: none"> • personal computers and personal computer monitors; • television receivers; • refrigerators and freezers having one or more variable-speed drives to control compressor motor(s). 			
NOTE 2 Class D limits are reserved for equipment that, by virtue of the factors listed in note 1, can be shown to have a pronounced effect on the public electricity supply system.			
*Starting and stopping When a piece of equipment is brought into operation or is taken out of operation, manually or automatically, harmonic currents and power are not taken into account for the first 10 s following the switching event. The equipment under test shall not be in stand-by mode (see 3.14) for more than 10 % of any observation period.			

Table 18: Harmonic Current Emissions – Classification of Equipment

Tested Line	Limit	Observation Time (min)	Harmonics Repeatability Verification ≤5%	Results
Power (230V/50Hz)	Class A	2	YES	Pass

The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client.

Table 19: Harmonic Current Emissions – Test Results

10.3.4 Test Data

See APPENDIX C for data files.



Photo 18: Harmonic Current Emissions – Test Setup

10.3.5 Test Method

Harmonic current emissions measurements were performed using the procedures of the reference standard.

10.4 Voltage Fluctuations and Flicker Measurements

10.4.1 Test Details

REFERENCE STANDARD	EN 61000-3-3 (2013) A1 (2019) A2 (2021)
SPECIFICATIONS	
P_{st} Observation Period	10 min
P_{lt} Observation Period	120 min
EUT	
Identification	CAM230
Voltage Input	230V/50Hz
Manual Switching	NO
TEST INFO	
Test Date (yyyy-mm-dd)	2023-04-06
Temperature °C (For Info Only)	23.2°C
Relative humidity % (For Info Only)	28.2%
Atmospheric pressure kPa (For Info Only)	101.6kPa
Operator	Jean Cadotte
Client Witness	No witness
Test Report TR-0634371_R1	Page 48 / 112
F-032 Rev 80	

10.4.2 Test Equipment

Manufacturer	Description	Model	Serial No	Calibration Cycle (month)	Next Calibration (y-m-d)
TESEQ	Software	Win2100 v4.9	N/A	N/A	N/A
TESEQ	AC-DC Power source	NSG 1007	1232A04499 (NSG 1007)	24	2023-09-14
TESEQ	Lumped impedance	CCN 1000-1	1232A04499 (CCN 1000-1)	24	2023-09-14

Table 20: Voltage Fluctuations and Flicker Measurements – Test Equipment

10.4.3 Test Results

Parameters	Limit	Results
Short-term flicker value: P_{st}	1.0	Pass
Long-term flicker value: P_{lt}	0.65	Pass
Voltage change for more than 500ms: $d(t)$	3.3%	Pass
Relative steady state voltage change: dc	3.3%	Pass
Maximum relative voltage change: d_{max}	4%	Pass

The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client.

Table 21: Voltage Fluctuations and Flicker Measurements – Test Results

10.4.4 Test Data

See APPENDIX D for data files.

Test setup was identical to harmonic current emissions measurements.

10.4.5 Test Method

Voltage fluctuations and flicker measurements were performed using the procedures of the reference standard.

11 IMMUNITY TESTS

11.1 Electrostatic Discharge Immunity

11.1.1 Test Details

REFERENCE STANDARD	IEC 61000-4-2 (2008)
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SPECIFICATIONS

Test Level	Contact: ±4kV Air: ±2kV, ±4kV, ±8kV
Installation	Table-top equipment
Ungrounded Equipment	YES

PERFORMANCE CRITERION	B
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EUT	
Identification	CAM230
Voltage Input	230V/50Hz

TEST INFO

Test Date (yyyy-mm-dd)	2023-04-06
Temperature Min 15°C – Max 35°C	24.5°C
Relative Humidity Min 30% - Max 60%	38.4%
Atmospheric Pressure Min 86kPa – Max 106kPa	101.5kPa
Operator	Jean Cadotte
Client Witness	Louis-Sacha Constantineau (Inogeni)

11.1.2 Test Equipment

Manufacturer	Description	Model	Serial No	Calibration Cycle (month)	Next Calibration (y-m-d)
Vaisala	Thermo-Hygrometer	MI70/HMP77	H4610004/JO430012	24	2023-08-13
EMC-Partner	Discharge Generator	ESD3000	2076	12	2023-08-26
EMC-Partner	Relay Module	ESD3000RM32	1822	12	2023-08-26
EMC-Partner	Discharge Network 150pF/330Ohms	ESD3000DN1	1777	12	2023-08-26

Table 22: ESD – Test Equipment

11.1.3 Test Results

Coupling Plane	Position	Polarity Test Level (kV)	Number	Time Interval (s)	Generator Perpendicular	Comments	Results
HCP	Front	± 4	10+ / 10-	1	YES	No event	Pass
VCP	Front	± 4	10+ / 10-	1	YES	Note 1	Pass
	Right	± 4	10+ / 10-	1	YES	No event	Pass
	Rear	± 4	10+ / 10-	1	YES	No event	Pass
	Left	± 4	10+ / 10-	1	YES	No event	Pass
The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client. See section 5 for further detail.							
Note 1: Due to cables, VCP was placed at 17cm from EUT (standard distance is 10cm).							

Table 23: ESD – Test Results – Indirect Discharges – CAM230

Coupling Plane	Position	Polarity Test Level (kV)	Number	Time Interval (s)	Generator Perpendicular	Comments	Results
HCP	Front	± 4	10+ / 10-	1	YES	No event	Pass
VCP	Front	± 4	10+ / 10-	1	YES	No event	Pass
	Right	± 4	10+ / 10-	1	YES	No event	Pass
	Rear	± 4	10+ / 10-	1	YES	No event	Pass
	Left	± 4	10+ / 10-	1	YES	No event	Pass
The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client. See section 5 for further detail.							

Table 24: ESD – Test Results – Indirect Discharges – PSU

ESD Point	ESD Type	Test Level (kV)	Number	Time Interval (s)	Generator Perpendicular	Comments	Results
C1 to C8	Contact	± 4	10+ / 10-	1	YES	No event	Pass
C9 to C14	Contact	± 4	10+ / 10-	1	YES	Note 1	Pass
NONE	Air	$\pm 2, \pm 4, \pm 8, \pm 15$	10+ / 10-	1	N/A	Note 2	Pass
The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client. See section 5 for further detail.							
Note 1: Self-recoverable degradation: Picture on the laptop flickers during a split of a second. Got back to normal by itself.							
Note 2: After discharge points research, no possible air discharge was found on the EUT.							
This test result is considered as a Pass according to performance criteria defined in section 5							

Table 25: ESD – Test Results – Direct Discharges

11.1.4 Test Data



Photo 19: ESD – Test Setup

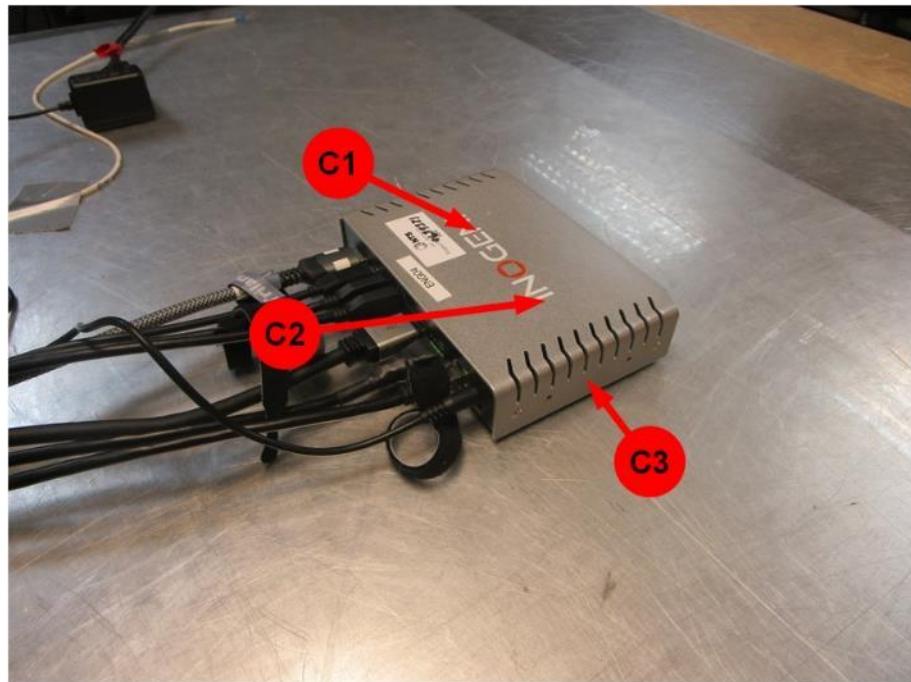


Photo 20: ESD – Location of Discharge Points #1

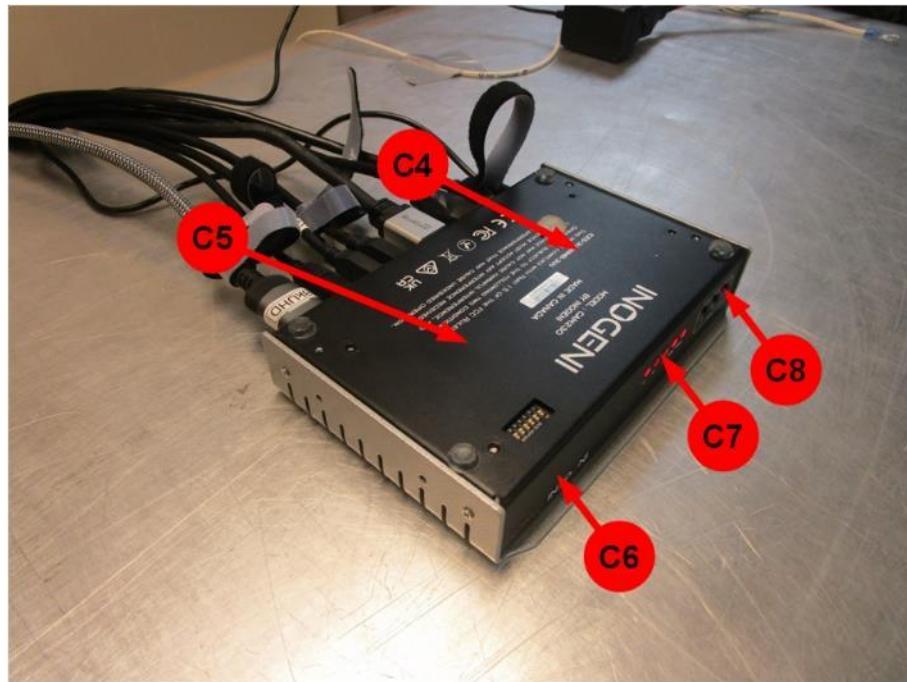


Photo 21: ESD – Location of Discharge Points #2

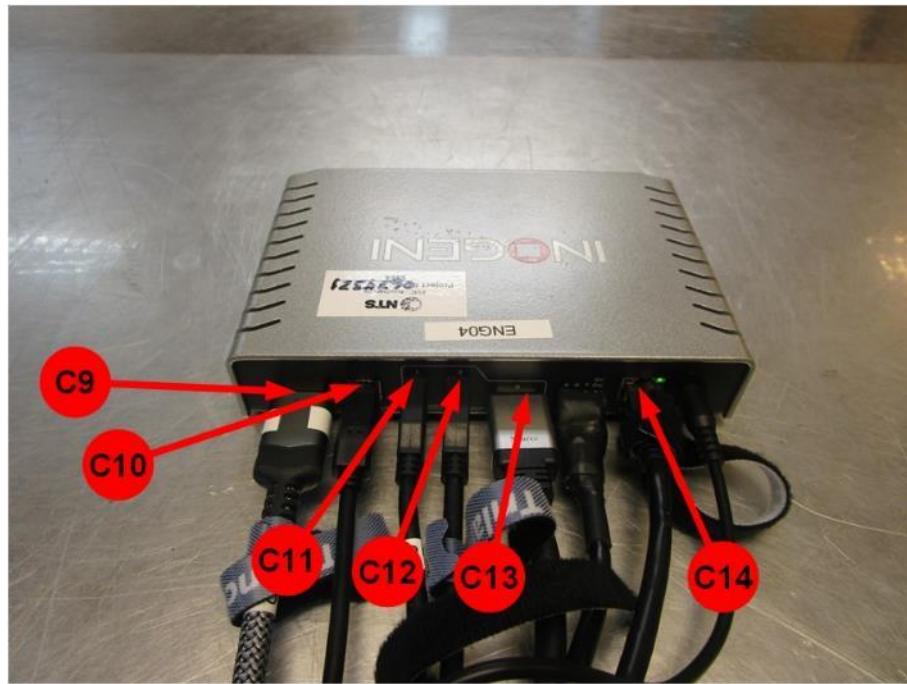


Photo 22: ESD – Location of Discharge Points #3

11.1.5 Test Method

Electrostatic discharge immunity tests were performed using the procedures of the reference standard.

Application of direct discharges was applied to points and surfaces of EUT which are accessible to person during normal use. If contact discharge cannot be applied, the air discharge method shall be performed.

Application of indirect discharges was applied to the horizontal coupling plane (0.1m from the front of EUT) and to vertical coupling plane (VCP is positioned at 0.1m from EUT in order to illuminate the four faces of EUT).

11.2 Radiated Electromagnetic Field Immunity

11.2.1 Test Details

REFERENCE STANDARD	IEC 61000-4-3 (2020)		
SPECIFICATIONS			
TEST	#1	#2	#3
Frequency Range	80MHz-1000MHz	1.8GHz-2.6GHz	3.5GHz, 5GHz
Test Level	3V/m	3V/m	20V/m
Test Distance	2m	2m	2.7m
Uniformity Field Area	Area: 1.5m x 1.5m Lower Edge @ 80cm Antenna Height @ 1.55m	Area: 1.5m x 1.5m Lower Edge @ 80cm Antenna Height @ 1.55m	Area: 1.5m x 1.5m Lower Edge @ 80cm Antenna Height @ 1.55m
Modulation	AM 80% / 1kHz	AM 80% / 1kHz	AM 80% / 1kHz
Frequency Step	1%	N/A	N/A
Dwell Time	0.5s	10s	10s
Illuminated Face	4		
Installation	Table-top equipment		
PERFORMANCE CRITERION	A		
EUT			
Identification	CAM230		
Voltage Input	230V/50Hz		
TEST INFO			
Test Date (yyyy-mm-dd)	2023-04-06		
Temperature °C (For Info Only)	23.2°C		
Relative humidity % (For Info Only)	28.2%		
Atmospheric pressure kPa (For Info Only)	101.6kPa		
Operator	Jean Cadotte		
Client Witness	Louis-Sacha Constantineau (Inogeni)		

11.2.2 Test Equipment

Manufacturer	Description	Model	Serial No	Calibration Cycle (month)	Next Calibration (y-m-d)
TDK	Immunity Anechoic Chamber	16706-2	5712	N/A	N/A
NEXIO	Software	BAT-EMC v2022.0.23.0	N/A	N/A	N/A
TESEQ	Signal generator	ITS 6006	33007	12	2023-09-29
Werlatone	Directional coupler (80MHz-1GHz)	C3908-10	98552	12	2023-12-22
Werlatone	Directional coupler (0.8GHz-3GHz)	C6721-10	98746	12	2023-12-22
Agilent	Directional coupler (2GHz-18GHz)	773D	MY28390533	12	2023-12-30
TESEQ	Power meter	PM 6006	72804	12	2023-09-29
TESEQ	Power meter	PM 6006	72805	12	2023-09-29
TESEQ	Power meter	PM 6006	77352	12	2023-09-29
TESEQ	Power meter	PM 6006	77353	12	2023-09-29
TESEQ	RF amplifier (80MHz-1GHz)	CBA 1G-500	T44193	VERIF	VERIF
TESEQ	RF amplifier (800MHz-3GHz)	CBA 3G-180	T44194	VERIF	VERIF
IFI	RF Amplifier (1GHz-6GHz)	S62-50	Q1539-0113	VERIF	VERIF
Schwarzbeck	Antenna	STLP 9128 D special	9128DS 025	VERIF	VERIF
Com-Power	Horn Antenna	AH-118	071324	24	2024-08-03
Narda	Electric Field Probe	PMM EP604	811ZX20408	12	2023-10-14
LABCEM	RF Uniformity Field 80MHz-1GHz (36V/m)	N/A	N/A	12	2023-12-27
LABCEM	RF Uniformity Field 1GHz-3GHz (18V/m)	N/A	N/A	12	2023-12-27
LABCEM	RF Uniformity Field 3GHz-6GHz (9V/m) <u>COM-POWER</u>	N/A	N/A	12	2023-12-30

Table 26: Radiated EM Field – Test Equipment

11.2.3 Test Results

Illuminated Face	Frequencies (MHz)	Test Level (V/m)	Modulation	Polarization	Comments	Results
Front	80 - 1000	3	AM / 1kHz	Horizontal Vertical	No event Note1	Pass
	1800, 2600	3	AM / 1kHz	Horizontal Vertical	No event Note1	Pass
	3500, 5000	3	AM / 1kHz	Horizontal Vertical	No event Note1	Pass
Right	80 - 1000	3	AM / 1kHz	Horizontal Vertical	No event	Pass
	1800, 2600	3	AM / 1kHz	Horizontal Vertical	No event	Pass
	3500, 5000	3	AM / 1kHz	Horizontal Vertical	No event	Pass
Rear	80 - 1000	3	AM / 1kHz	Horizontal Vertical	No event	Pass
	1800, 2600	3	AM / 1kHz	Horizontal Vertical	No event	Pass
	3500, 5000	3	AM / 1kHz	Horizontal Vertical	No event	Pass
Left	80 - 1000	3	AM / 1kHz	Horizontal Vertical	No event	Pass
	1800, 2600	3	AM / 1kHz	Horizontal Vertical	No event	Pass
	3500, 5000	3	AM / 1kHz	Horizontal Vertical	No event	Pass
The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client. See section 5 for further detail.						
Note 1: 1m of cable was exposed to the electromagnetic field						

Table 27: Radiated EM Field – Test Results

11.2.4 Test Data



Photo 23: Radiated EM Field – Test setup – Front



Photo 24: Radiated EM Field – Test setup – Right



Photo 25: Radiated EM Field – Test setup – Rear



Photo 26: Radiated EM Field – Test setup – Left



Photo 27: Radiated EM Field – Test setup – >3GHz

11.2.5 Test Method

Radiated field immunity tests were performed using the procedures of the reference standard.

During the first illuminated face of EUT, radiated immunity test equipment's were verified by monitoring the EM field.

11.3 Electrical Fast Transient Immunity

11.3.1 Test Details

REFERENCE STANDARD	IEC 61000-4-4 (2012)
SPECIFICATIONS	
Test Level	Power Ports: $\pm 1\text{kV}$ I/O Ports: $\pm 0.5\text{kV}$ Communication Ports: $\pm 0.5\text{kV}$
Repetition Frequency	5kHz
Installation	Table-top equipment
PERFORMANCE CRITERION	B
EUT	
Identification	CAM230
Voltage Input	230V/50Hz
TEST INFO	
Test Date (yyyy-mm-dd)	2023-04-06
Temperature °C (For Info Only)	25.6°C
Relative humidity % (For Info Only)	34.1%
Atmospheric pressure kPa (For Info Only)	101.6kPa
Operator	Jean Cadotte
Client Witness	Louis-Sacha Constantineau (Inogeni)

11.3.2 Test Equipment

Manufacturer	Description	Model	Serial No	Calibration Cycle (month)	Next Calibration (y-m-d)
EMC-Partner	Software	GENECS 3.28	N/A	N/A	N/A
EMC-Partner	Transient Test System	TRA3000	1507	18	2023-08-25
TESEQ	EFT Clamp	CDN 3425	1730	12	2023-11-01

Table 28: EFT – Test Equipment

11.3.3 Test Results

Tested Line	Polarity Test level (kV)	Coupling Method	Repetition Frequency (kHz)	Test Duration By Polarity (s)	Comments	Results
L, N, PE	±1	CDN	5	60	No event	Pass
All cables	±0.5	Capacitive clamp	5	60	No event	Pass

The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client. See section 5 for further detail.

Table 29: EFT – Test Results

11.3.4 Test Data

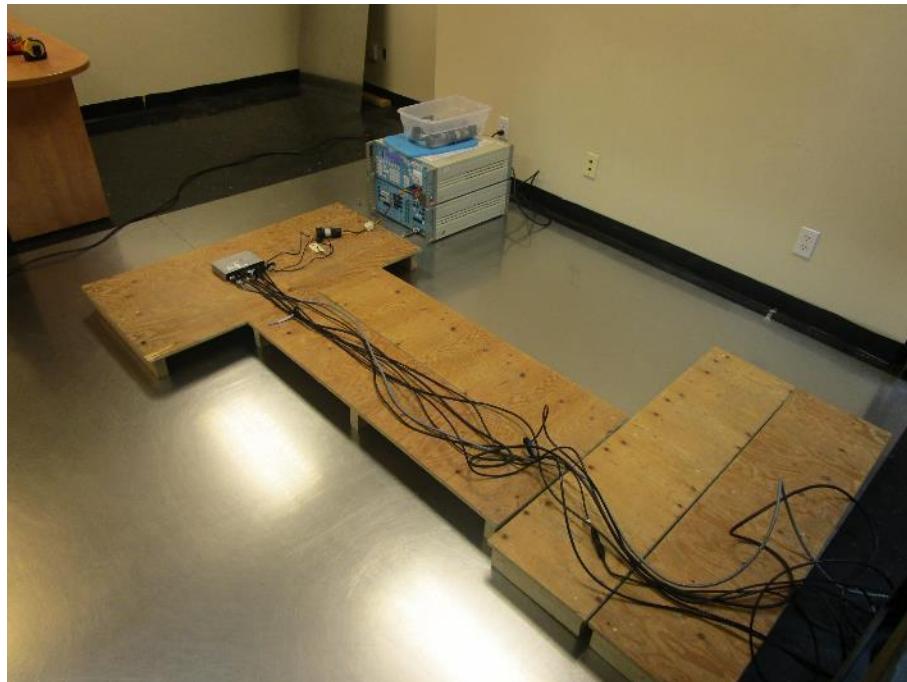


Photo 28: EFT – Test Setup

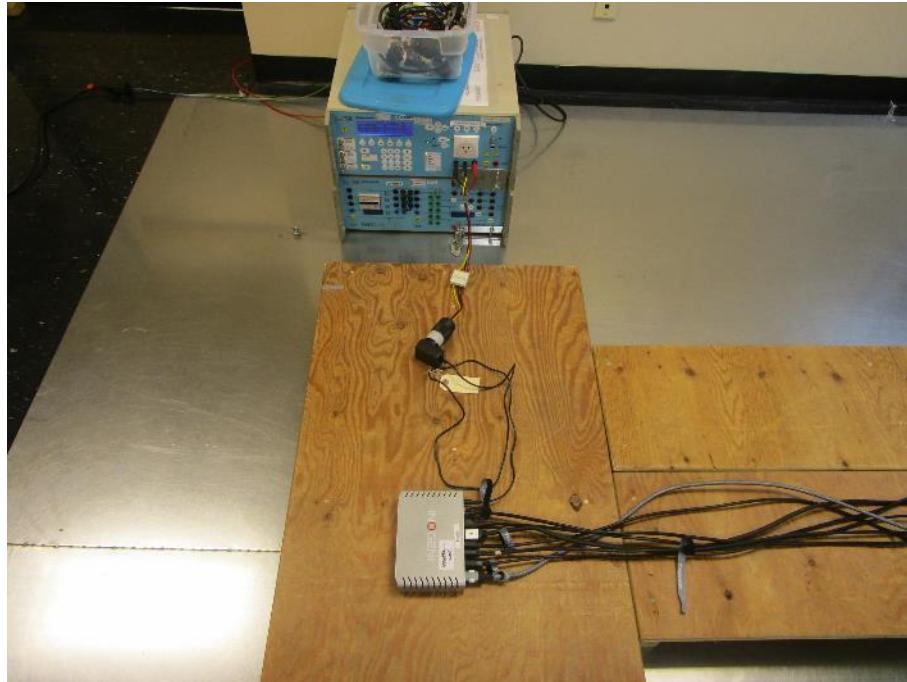


Photo 29: EFT – Test Setup – CDN – Power

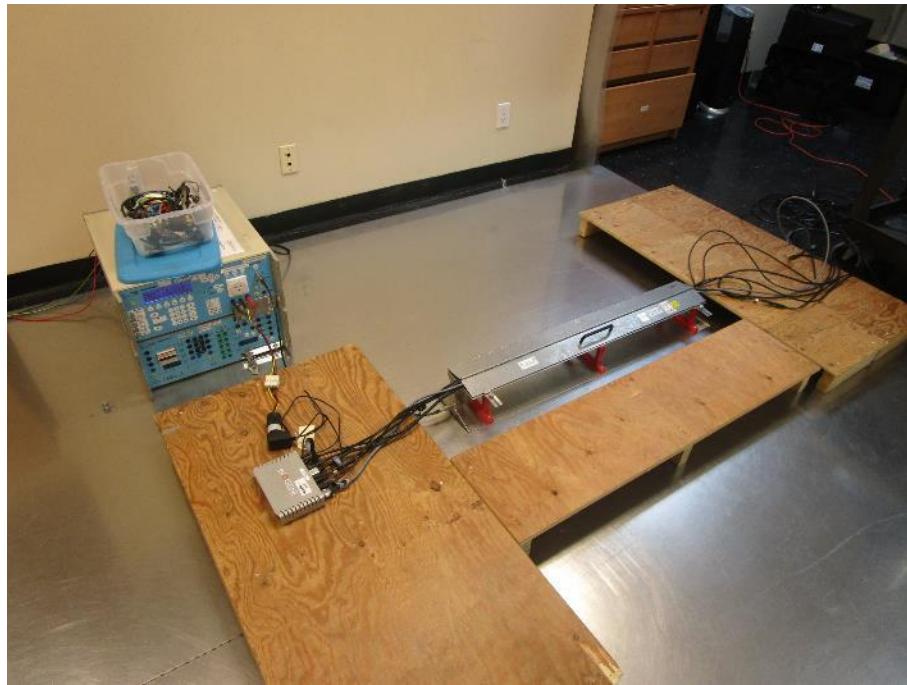


Photo 30: EFT – Test Setup – Capacitive Clamp – All cables

11.3.5 Test Method

Electrical fast transient immunity tests were performed using the procedures of the reference standard.

11.4 Surge Immunity

11.4.1 Test Details

REFERENCE STANDARD	IEC 61000-4-5 (2014) A1 (2017)
SPECIFICATIONS	
1.2/50µs Waveform	Open-Circuit Voltage: 1.2µs/50µs Short-Circuit Current: 8µs/20µs
Test level	Power: ±2kV L-PE / ±1kV L-L I/O Ports: N/A Communication Ports: N/A
PERFORMANCE CRITERION	B
EUT	
Identification	CAM230
Voltage Input	230V/50Hz
TEST INFO	
Test Date (yyyy-mm-dd)	2023-04-06
Temperature °C (For Info Only)	23.2°C
Relative humidity % (For Info Only)	28.2%
Atmospheric pressure kPa (For Info Only)	101.6kPa
Operator	Jean Cadotte
Client Witness	No witness

11.4.2 Test Equipment

Manufacturer	Description	Model	Serial No	Calibration Cycle (month)	Next Calibration (y-m-d)
EMC-Partner	Software	GENECS 3.28	N/A	N/A	N/A
EMC-Partner	Transient Test System	TRA3000	1507	18	2023-08-25
EMC-Partner	Coupling/Decoupling Network	CDN2000-6-32	CDN2000-6-32 0175	VERIF	VERIF

Table 30: Surge – Test Equipment

11.4.3 Test Results

Application		Polarity Test Level (kV)	Additional Impedance	Number	Interval (s)	Phase Shifting (°)	Comments	Results
between	and							
L	PE	+0.5 +1 +2	10Ω	5+	30	90	Note 1	Pass
L	PE	-0.5 -1 -2	10Ω	5-	30	270	Note 1	Pass
N	PE	-0.5 -1 -2	10Ω	5-	30	90	Note 1	Pass
N	PE	+0.5 +1 +2	10Ω	5+	30	270	Note 1	Pass
L	N	+0.5 +1	0Ω	5+	30	90	No event	Pass
L	N	-0.5 -1	0Ω	5-	30	270	No event	Pass
The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client. See section 5 for further detail.								
Note 1: EUT without PE, no L vs PE test performed								

Table 31: 1.2/50μs Surge – Test Results – Power Ports

11.4.4 Test Data



Photo 31: 1.2/50 μ s Surge – Test Setup

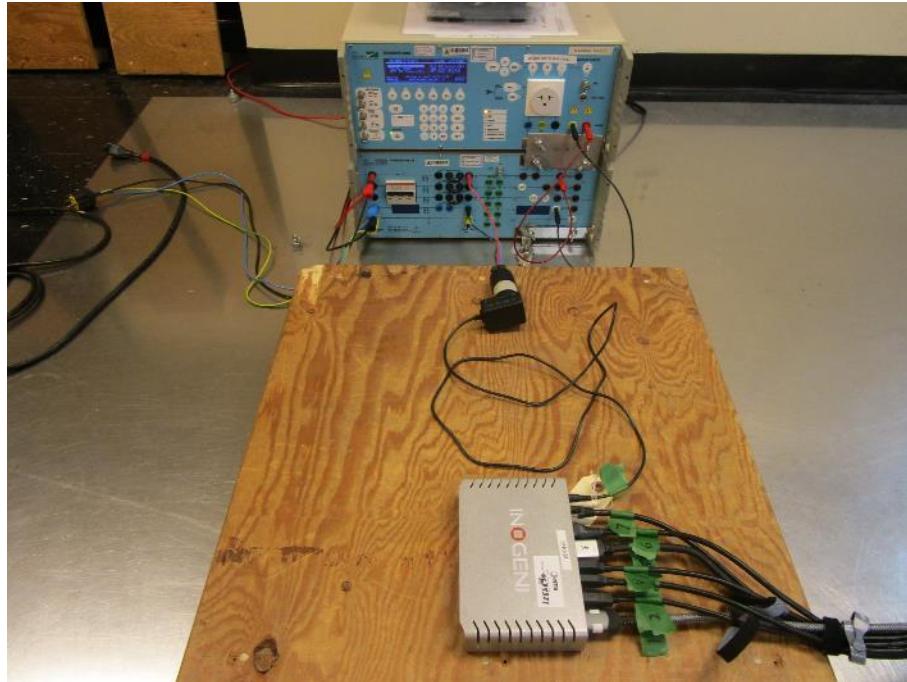


Photo 32: 1.2/50 μ s Surge – Test Setup – Power Ports

11.4.5 Test Method

Surge immunity tests were performed using the procedures of the reference standard.

11.5 Conducted Disturbances Immunity

11.5.1 Test Details

REFERENCE STANDARD	IEC 61000-4-6 (2013)
SPECIFICATIONS	
Test level	Power: 3Vrms I/O Ports: 3Vrms Communication Ports: 3Vrms
Frequency Range	150kHz-80MHz
Modulation	AM: 80% / 1kHz
Frequency Step	1%
Dwell Time	0.5s
PERFORMANCE CRITERION	A
EUT	
Identification	CAM230
Voltage Input	230V/50Hz
TEST INFO	
Test Date (yyyy-mm-dd)	2023-04-10
Temperature °C (For Info Only)	22.8°C
Relative humidity % (For Info Only)	26.6%
Atmospheric pressure kPa (For Info Only)	102.9kPa
Operator	Jean Cadotte
Client Witness	No witness

11.5.2 Test Equipment

Manufacturer	Description	Model	Serial No	Calibration Cycle (month)	Next Calibration (y-m-d)
NEXIO	Software	BAT-EMC v2022.0.23.0	N/A	N/A	N/A
TESEQ	Conducted Immunity Test Generator	NSG 4070B-75	34302	12	2023-10-13
TESEQ	CDN M2/M3	CDN M016	34597	24	2024-10-05
TESEQ	CDN M2	CDN M216	32740	24	2024-10-05
TESEQ	EM Clamp	KEMZ 801A	33460	24	2024-09-22
TESEQ	RF Current Clamp	MD 4070	33320	24	2024-10-17
TESEQ	Attenuation Clamp	KEMA 801A	33174	NCR	NCR
TESEQ	Attenuation Clamp	KEMA 801A	34759	NCR	NCR
Pasternack	6dB Fixed Attenuator 150W	PE7AP150-06	LABCEM #0287	VERIF	VERIF
LABCEM	Laboratory 3 - Conducted Voltage Immunity Calibration CDN-M2 - CI Injection Cable	N/A	N/A	12	2023-10-13
LABCEM	Laboratory 3 - Conducted Voltage Immunity Calibration EM Clamp (sn:33460) - CI Injection Cable + CI Monitoring Cable	N/A	N/A	12	2023-10-13

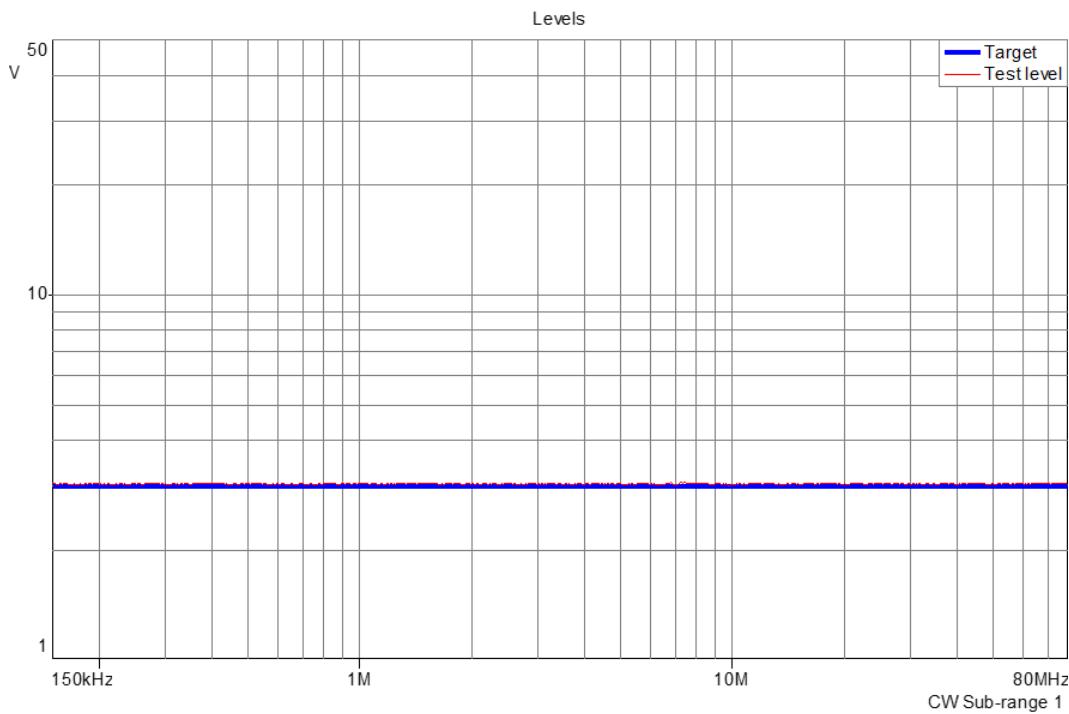
Table 32: Conducted Disturbances – Test Equipment

11.5.3 Test Results

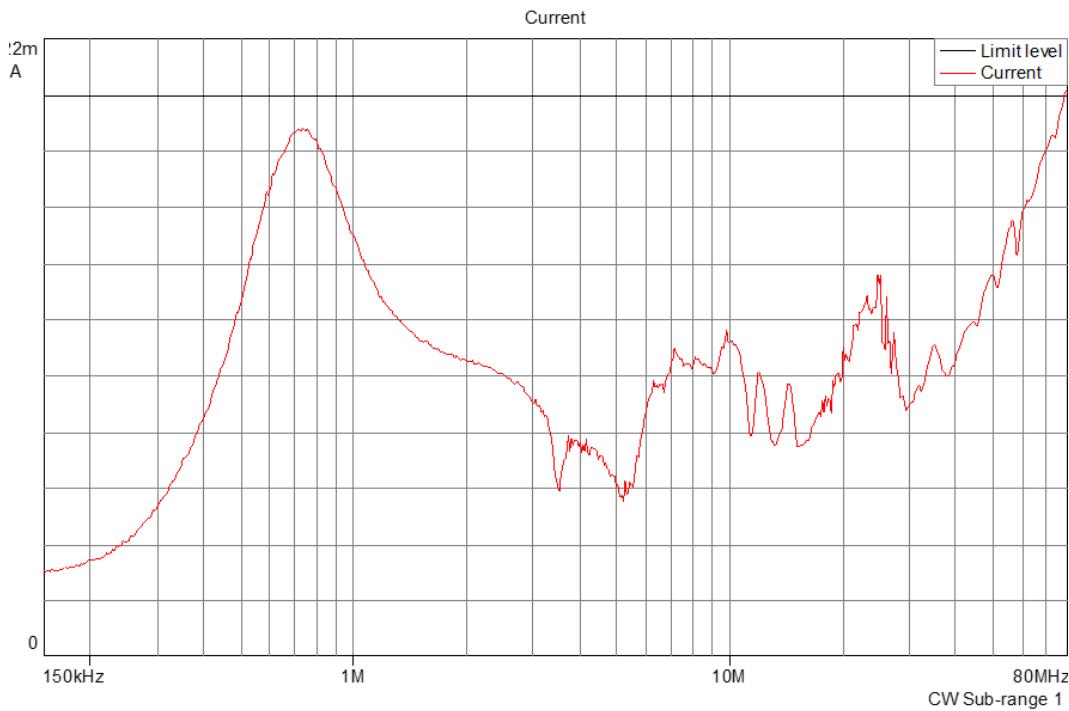
Tested Line	Coupling Method	Frequency (MHz)	Test Level (V)	Modulation	Comments	Results
Power (230V/50Hz)	CDN-M2	0.150 - 80	3	AM / 1kHz	No event	Pass
HDMI Out, USB	EM Clamp	0.150 - 80	3	AM / 1kHz	No event	Pass
RS-232, Eth	EM Clamp	0.150 - 80	3	AM / 1kHz	No event	Pass
The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client. See section 5 for further detail.						

Table 33: Conducted Disturbances – Test Results

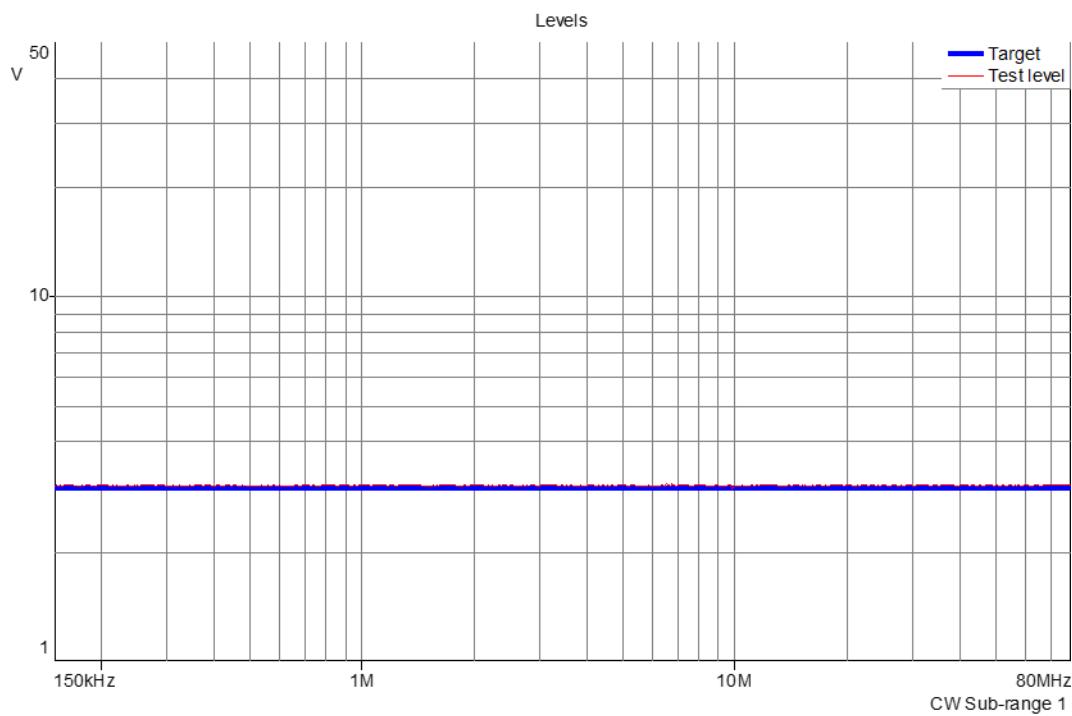
11.5.4 Test Data



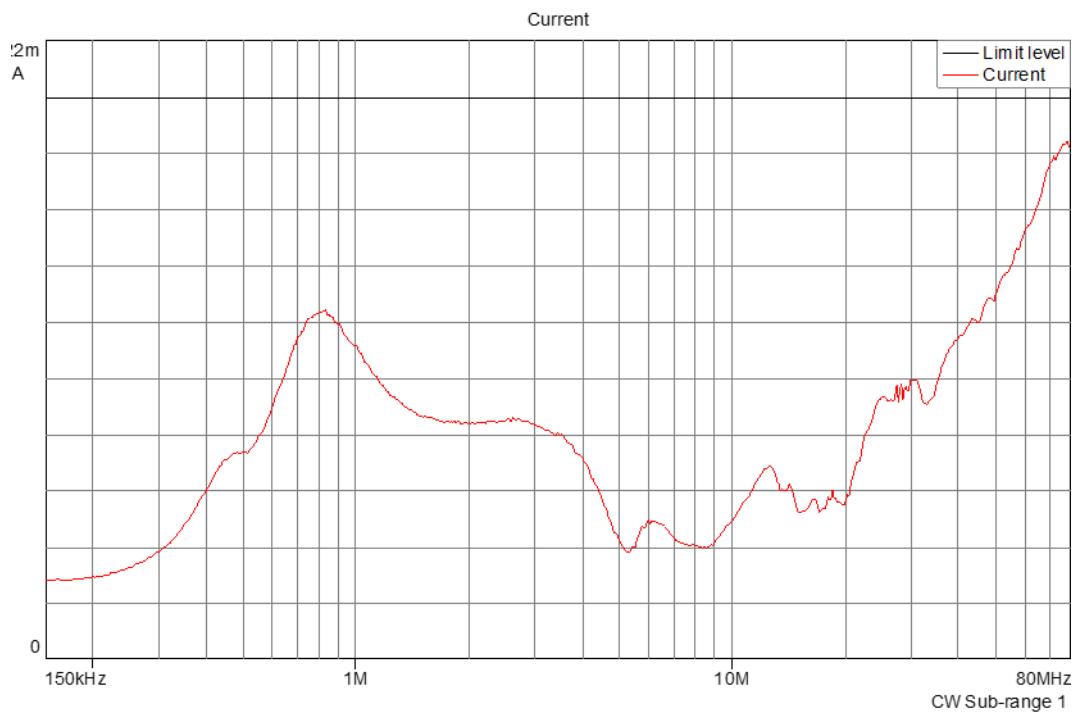
Graph 9: Conducted Disturbances – Voltage Level – EM Clamp – HDMI Out - USB



Graph 10: Conducted Disturbances – Current Measurements – EM Clamp – HDMI Out - USB



Graph 11: Conducted Disturbances – Voltage Level – EM Clamp – RS-232 - Eth



Graph 12: Conducted Disturbances – Current Measurements – EM Clamp – RS-232 - Eth

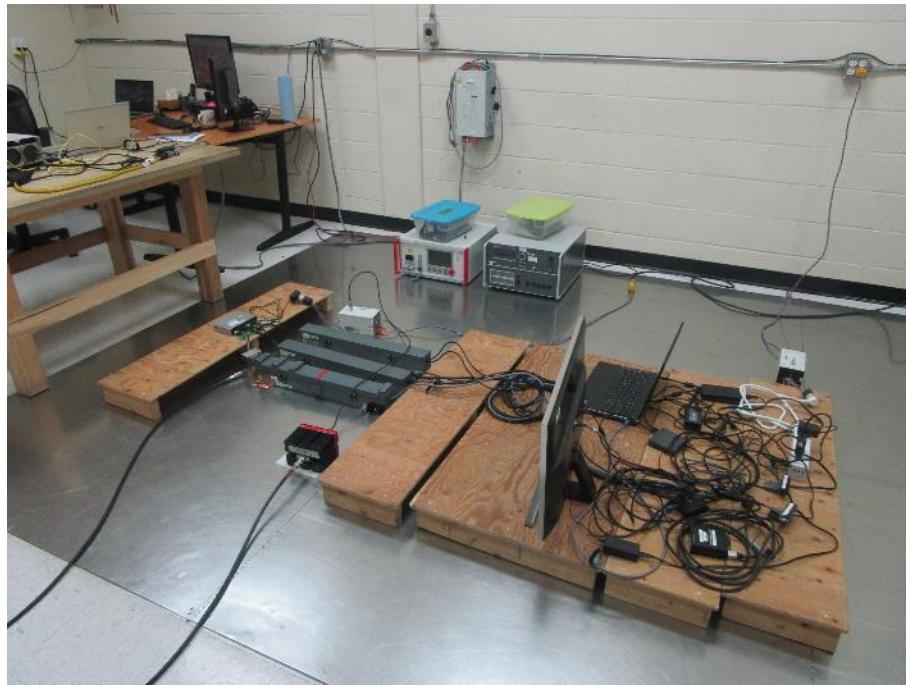


Photo 33: Conducted Disturbances – Test Setup

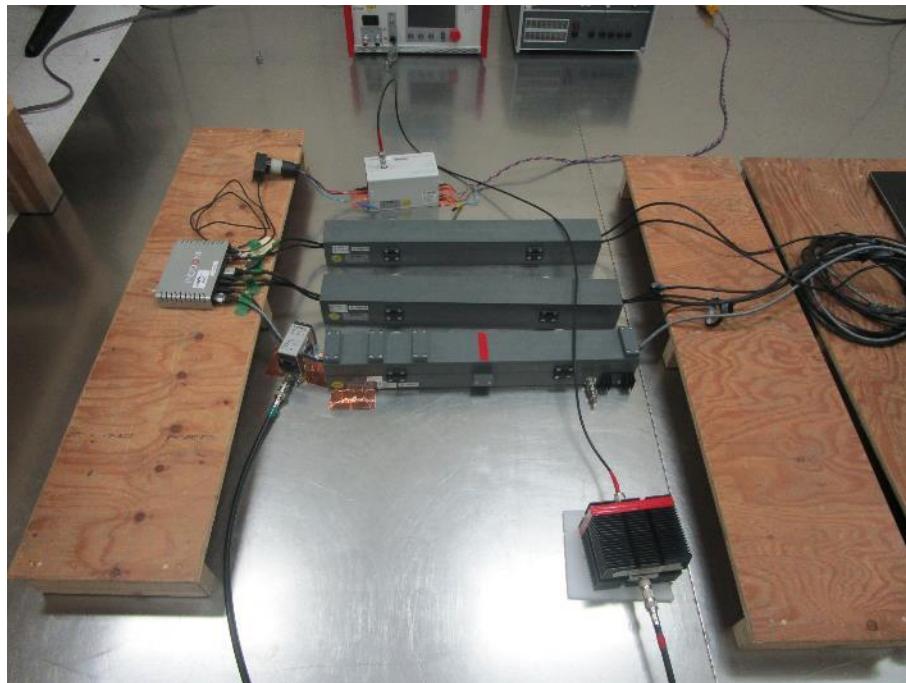


Photo 34: Conducted Disturbances – Test Setup – CDN – Power

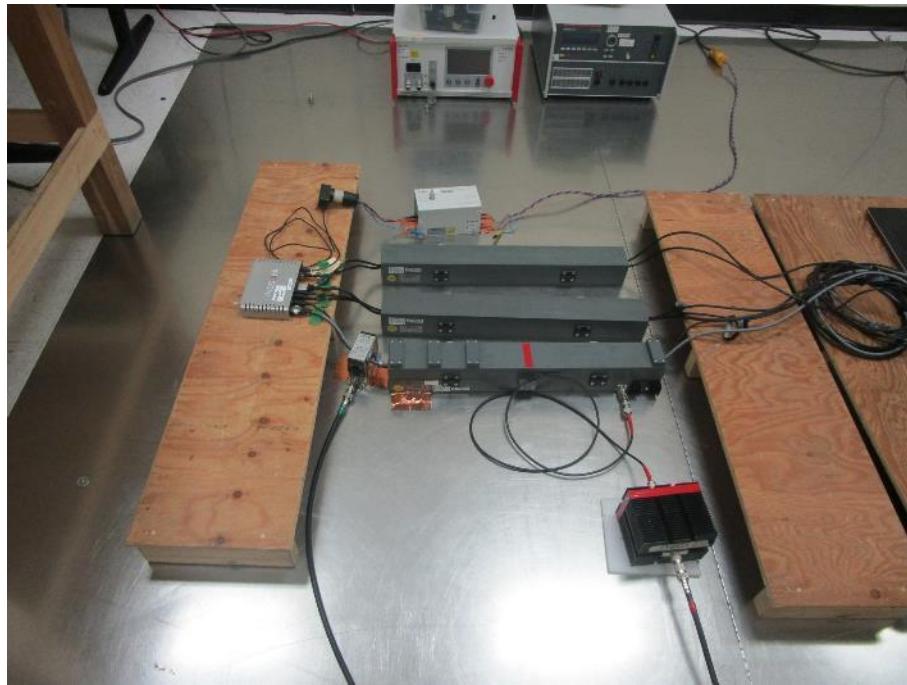


Photo 35: Conducted Disturbances – Test Setup – EM Clamp – HDMI Out - USB

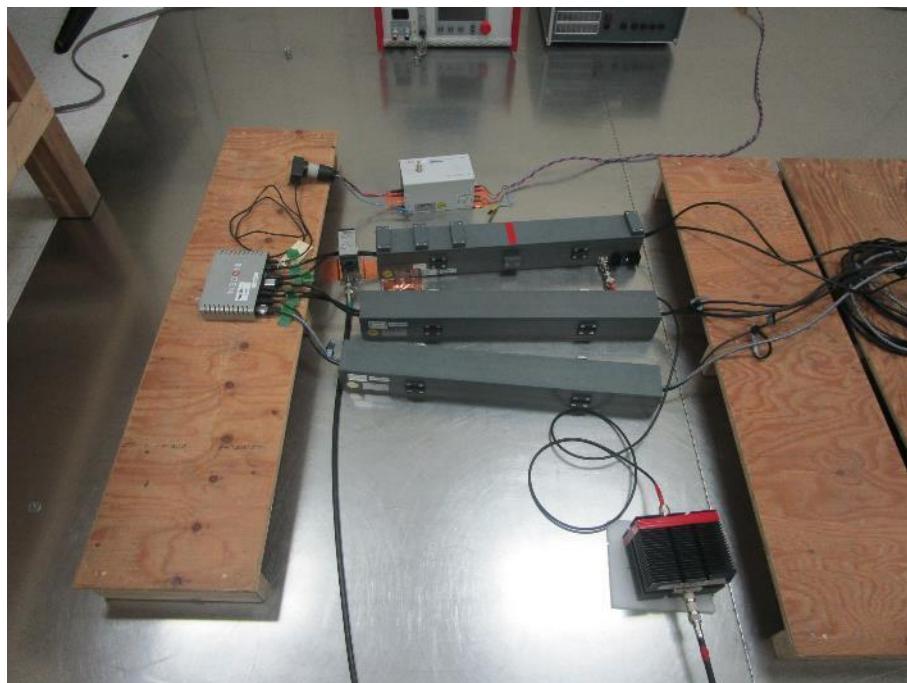


Photo 36: Conducted Disturbances – Test Setup – EM Clamp – RS-232 - Eth

11.5.5 Test Method

Conducted Disturbances immunity tests were performed using the procedures of the reference standard.

11.6 Power Frequency Magnetic Field Immunity

11.6.1 Test Details

REFERENCE STANDARD	IEC 61000-4-8 (2009)
---------------------------	----------------------

SPECIFICATIONS

Test Level	Continuous field: 1A/m (60s)
Frequency	50Hz / 60Hz
Induction Coil	1m x 1m

PERFORMANCE CRITERION	A
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EUT

Identification	CAM230
Voltage Input	230V/50Hz 120V/60Hz

TEST INFO

Test Date (yyyy-mm-dd)	2023-04-06
Temperature °C (For Info Only)	23.2°C
Relative humidity % (For Info Only)	28.2%
Atmospheric pressure kPa (For Info Only)	101.6kPa
Operator	Jean Cadotte
Client Witness	No witness

11.6.2 Test Equipment

Manufacturer	Description	Model	Serial No	Calibration Cycle (month)	Next Calibration (y-m-d)
TESEQ	Software	Win2120 v6.0 BETA	N/A	N/A	N/A
TESEQ	AC-DC Power source	NSG 1007	1232A04499 (NSG 1007)	24	2023-09-14
TESEQ	Magnetic coil interface	INA 2141	1417	NCR	NCR
TESEQ	Magnetic coil	INA 703	1978	VERIF	VERIF
Fluke	Digital Clamp Meter	353	21950072	12	2023-07-25
F.W. Bell	ELF Meter	4190	1237005	24	2024-10-21

Table 34: Magnetic Field – Test Equipment

11.6.3 Test Results

Position	Frequency (Hz)	Test Level (A/m)	Test Duration (s)	Comments	Results
1	50	1	60	No event	Pass
2	50	1	60	No event	Pass
3	50	1	60	No event	Pass

The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client. See section 5 for further detail.

Table 35: Magnetic Field – Test Results – 230V/50Hz

Position	Frequency (Hz)	Test Level (A/m)	Test Duration (s)	Comments	Results
1	60	1	60	No event	Pass
2	60	1	60	No event	Pass
3	60	1	60	No event	Pass

The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client. See section 5 for further detail.

Table 36: Magnetic Field – Test Results – 120V/60Hz

11.6.4 Test Data



Photo 37: Magnetic Field – Test Setup – Position #1

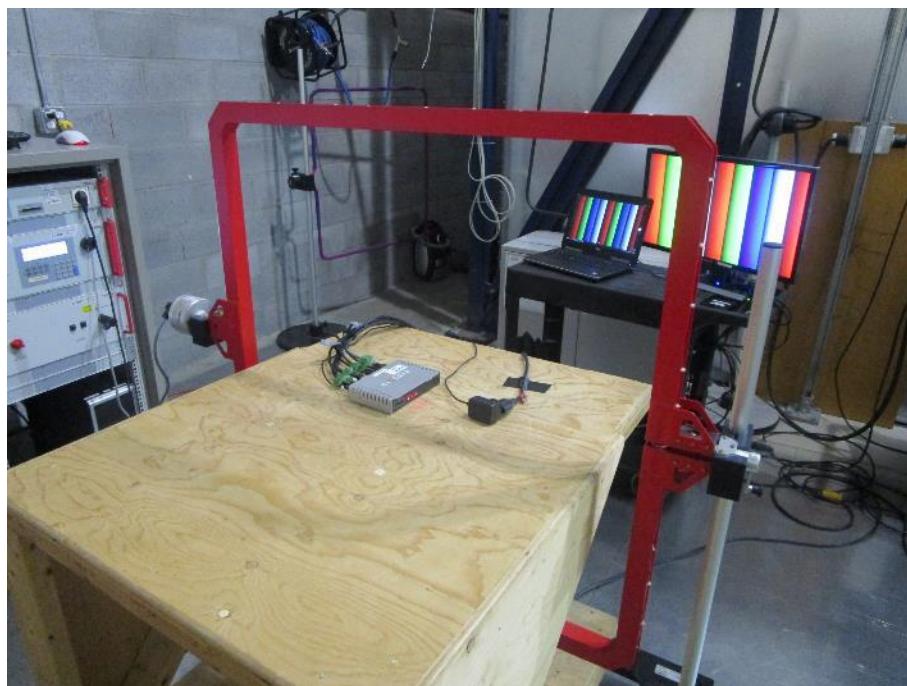


Photo 38: Magnetic Field – Test Setup – Position #2

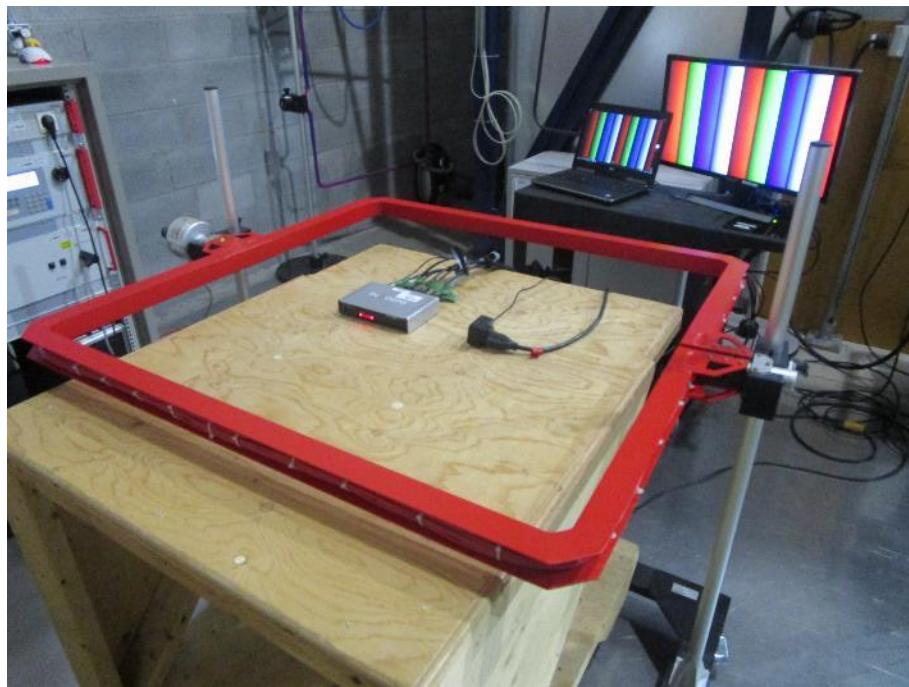


Photo 39: Magnetic Field – Test Setup – Position #3

11.6.5 Test Method

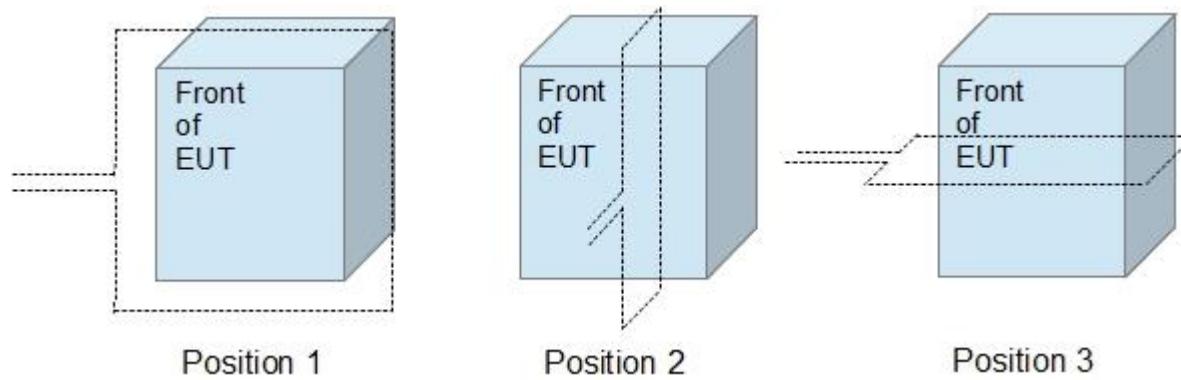


Figure 2: Magnetic Field – Position of Induction Coil

Power frequency field magnetic immunity tests were performed using the procedures of the reference standard.

11.7 Voltage Dips, Short Interruptions and Voltage Variation Immunity on AC input

11.7.1 Test Details

REFERENCE STANDARD	IEC 61000-4-11 (2020)
---------------------------	-----------------------

SPECIFICATIONS

Voltage Dips	0%Un: ½ cycle 70%Un: 25 cycles 70%Un: 30 cycles
Short Interruptions	0%Un: 250 cycles 0%Un: 300 cycles

PERFORMANCE CRITERION	0%Un / ½ cycle: B 70%Un / 25 cycles: C 70%Un / 30 cycles: C 0%Un / 250 cycles: C 0%Un / 300 cycles: C
------------------------------	---

EUT

Identification	CAM230
Voltage Input	240V/50Hz 100V/60Hz

TEST INFO

Test Date (yyyy-mm-dd)	2023-04-06
Temperature °C (For Info Only)	23.2°C
Relative humidity % (For Info Only)	28.2%
Atmospheric pressure kPa (For Info Only)	101.6kPa
Operator	Jean Cadotte
Client Witness	No witness

11.7.2 Test Equipment

Manufacturer	Description	Model	Serial No	Calibration Cycle (month)	Next Calibration (y-m-d)
EMC-Partner	Software	GENECS 3.28	N/A	N/A	N/A
EMC-Partner	Transient Test System	TRA3000	1507	18	2023-08-25

Table 37: Voltage Variations on AC Input – Test Equipment

11.7.3 Test Results

Tested line	Test Level (% Un)	Duration (Cycle)	Number	Interval (s)	Phase Shifting (°)	Comments	Results
Power (240V/50Hz)	0	1/2	3	10	0	No event	Pass
	70	25	3	10	0	No event	Pass
	0	250	3	10	0	No event	Pass
Power (100V/60Hz)	0	1/2	3	10	0	No event	Pass
	70	30	3	10	0	No event	Pass
	0	300	3	10	0	No event	Pass

The decision rule used to determine the test results is based on the limits stated in the test standard and the functional requirement provided by the client. See section 5 for further detail.

Table 38: Voltage Variations on AC Input – Test Results

11.7.4 Test Data

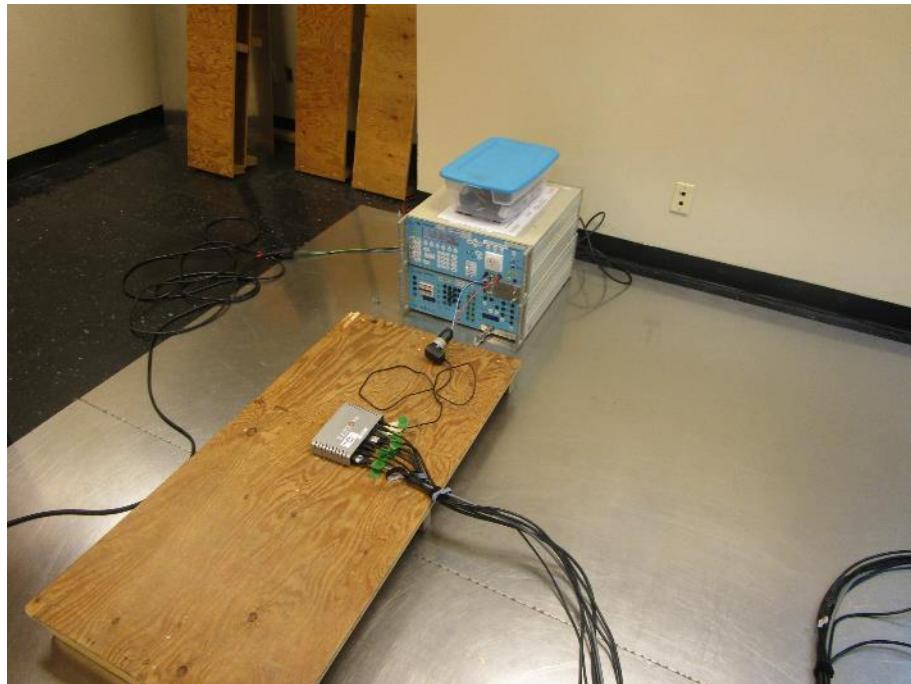


Photo 40: Voltage Variations on AC Input – Test Setup

11.7.5 Test Method

Voltage dips, short interruptions and voltage variation on AC Input immunity tests were performed using the procedures of the reference standard.

**APPENDIX A
CONDUCTED EMISSIONS**


CONDUCTED EMISSIONS - VOLTAGE
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Project: OP0634371

Customer: Inogeni

DESCRIPTION OF EQUIPMENT UNDER TEST (EUT)

Equipment: CAM230

Manufacturer: Inogeni

Hardware Version:

Software Version:

CONDUCTED EMISSIONS MEASUREMENT: OP0634371_EN55032-LISN_Phase_#10

Test Location: Anechoic chamber

Test Date: 2023-04-05 2:17:25 PM

Operator(s): Jean Cadotte

Test Standard: EN55032 Class A

Power: 230V/50Hz

Tested Line: Phase

Operating Mode:

Comments:

TEST PARAMETERS

TEST EQUIPMENT USED

Frequency Range
150 kHz - 30 MHzBandwidth
9 kHzLF#1+LF#2
LISN : PMM L2-16B#20801-red
Rohde & Schwarz : ESW44

FINAL RESULTS - QUASI-PEAK

Frequency	SR #	Quasi-Peak Detector (dB μ V)	Quasi-Peak Limit (dB μ V)	Margin (dB)	Correction (dB)
468.059 kHz	1	51.936	79	27.064	0.134
900.779 kHz	1	43.201	73	29.799	0.138
1.51135 MHz	1	42.272	73	30.728	0.144
4.798774 MHz	1	38.575	73	34.425	0.214
6.18994 MHz	1	39.354	73	33.646	0.252
7.305307 MHz	1	37.719	73	35.281	0.284

FINAL RESULTS - AVERAGE

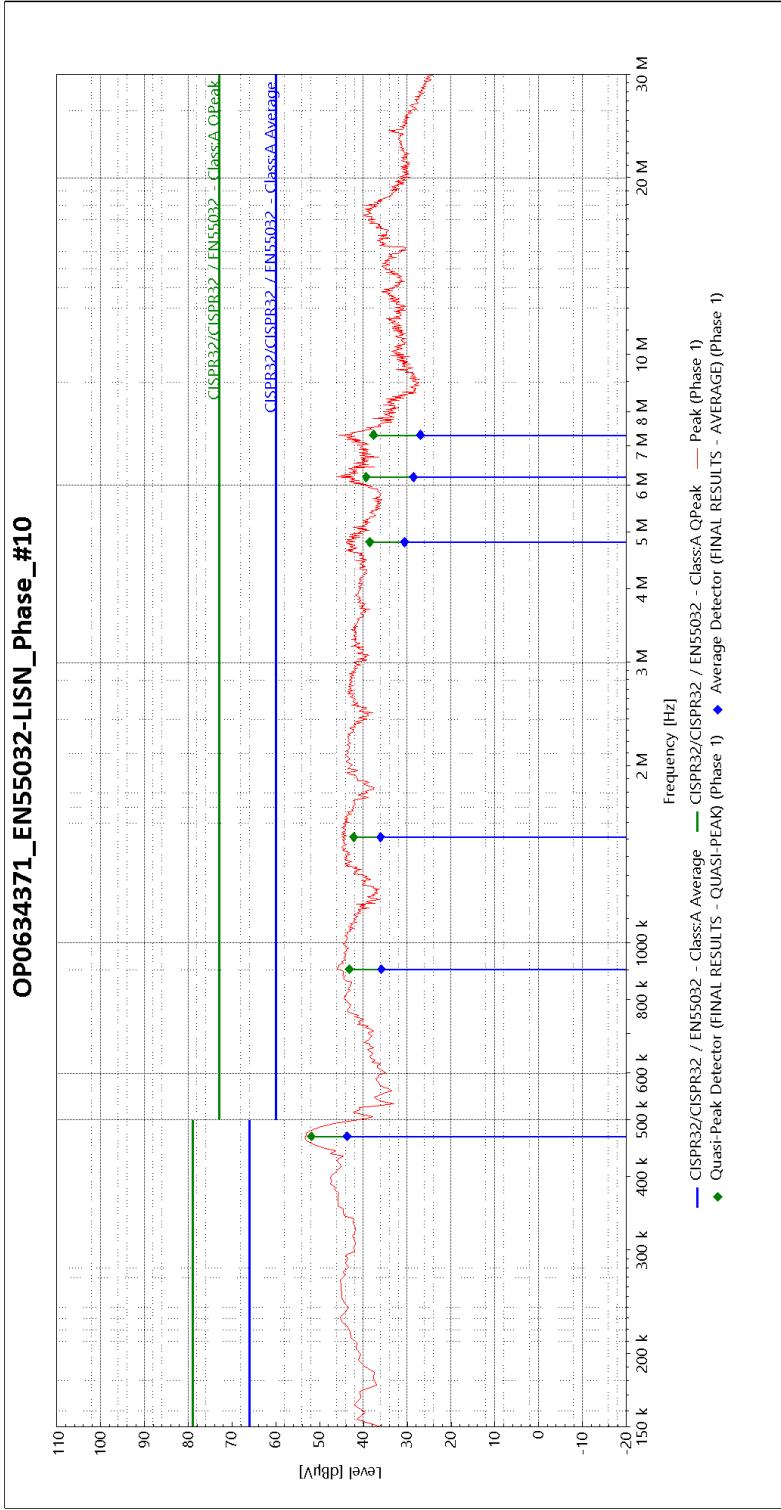
Frequency	SR #	Average Detector (dB μ V)	Average Limit (dB μ V)	Margin (dB)	Correction (dB)
468.059 kHz	1	43.732	66	22.268	0.134
900.779 kHz	1	35.902	60	24.098	0.138
1.51135 MHz	1	36.069	60	23.931	0.144
4.798774 MHz	1	30.641	60	29.359	0.214
6.18994 MHz	1	28.628	60	31.372	0.252
7.305307 MHz	1	27.03	60	32.97	0.284



CONDUCTED EMISSIONS - VOLTAGE
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OP0634371_EN55032-LISN_Phase_#10




CONDUCTED EMISSIONS - VOLTAGE
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Project: OP0634371**Customer:** Inogeni**DESCRIPTION OF EQUIPMENT UNDER TEST (EUT)**

Equipment: CAM230

Manufacturer: Inogeni

Hardware Version:

Software Version:

CONDUCTED EMISSIONS MEASUREMENT: OP0634371_EN55032_-LISN_Neutral_#11

Test Location: Anechoic chamber

Test Date: 2023-04-05 2:29:47 PM

Operator(s): Jean Cadotte

Test Standard: EN55032 Class A

Power: 230V/50Hz

Tested Line: Neutral

Operating Mode:

Comments:

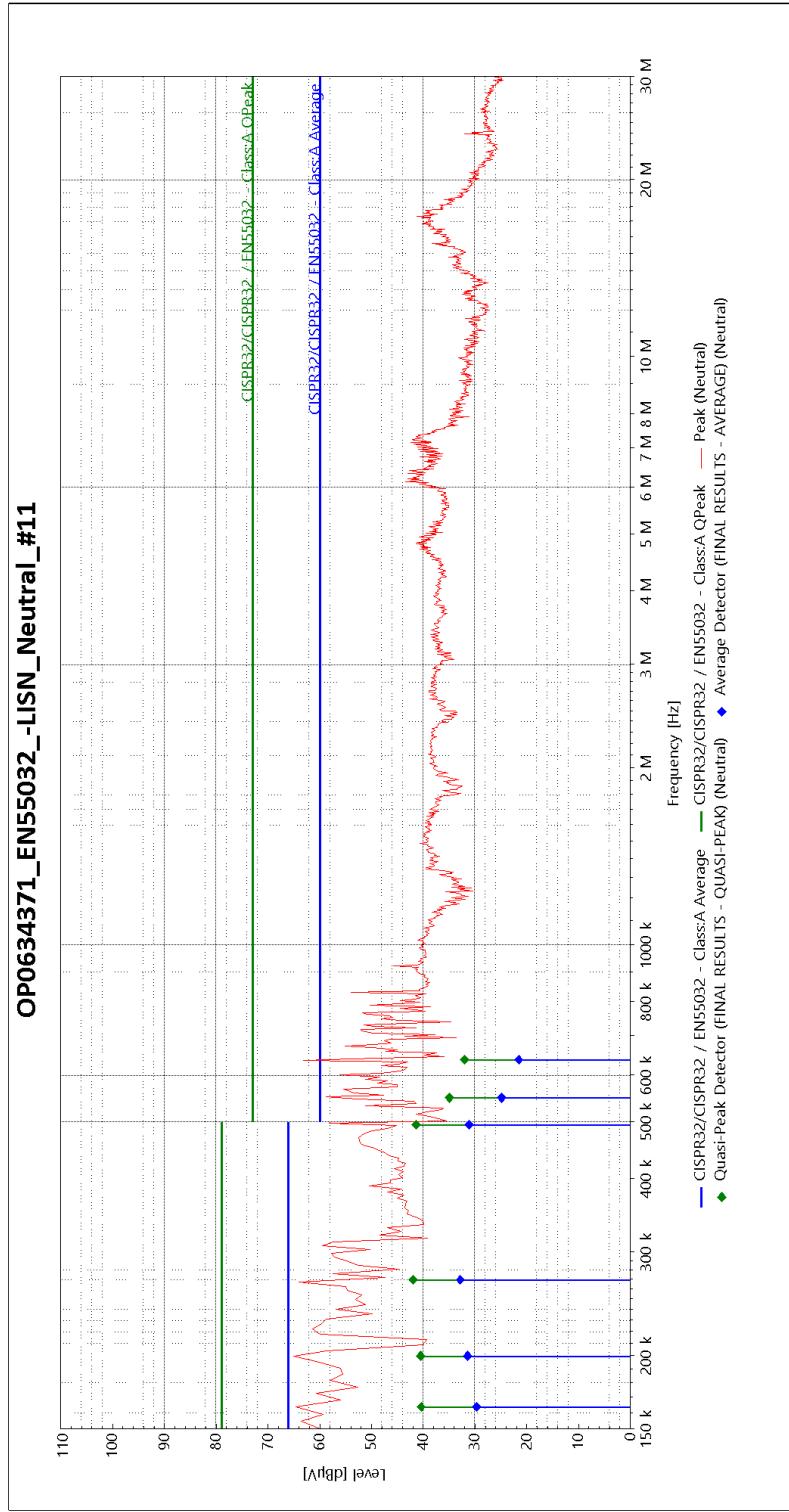
TEST PARAMETERSFrequency Range
150 kHz - 30 MHzBandwidth
9 kHz**TEST EQUIPMENT USED**LF#1+LF#2
LISN : PMM L2-16B#20801-red
Rohde & Schwarz : ESW44**FINAL RESULTS - QUASI-PEAK**

Frequency	SR #	Quasi-Peak Detector (dB μ V)	Quasi-Peak Limit (dB μ V)	Margin (dB)	Correction (dB)
163.565 kHz	1	40.424	79	38.576	0.331
199.851 kHz	1	40.523	79	38.477	0.331
269.144 kHz	1	41.92	79	37.08	0.332
494.289 kHz	1	41.349	79	37.651	0.344
548.943 kHz	1	34.988	73	38.012	0.344
637.237 kHz	1	31.991	73	41.009	0.345

FINAL RESULTS - AVERAGE

Frequency	SR #	Average Detector (dB μ V)	Average Limit (dB μ V)	Margin (dB)	Correction (dB)
163.565 kHz	1	29.66	66	36.34	0.331
199.851 kHz	1	31.397	66	34.603	0.331
269.144 kHz	1	32.841	66	33.159	0.332
494.289 kHz	1	31.146	66	34.854	0.344
548.943 kHz	1	24.839	60	35.161	0.344
637.237 kHz	1	21.567	60	38.433	0.345

CONDUCTED EMISSIONS - VOLTAGE
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CONDUCTED EMISSIONS - VOLTAGE
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Project: OP0634371**Customer:** Inogeni**DESCRIPTION OF EQUIPMENT UNDER TEST (EUT)**

Equipment: CAM230

Manufacturer: Inogeni

Hardware Version:

Software Version:

CONDUCTED EMISSIONS MEASUREMENT: OP0634371_FCC-LISN_Phase_#08

Test Location: Anechoic chamber

Test Date: 2023-04-05 1:49:44 PM

Operator(s): Jean Cadotte

Test Standard: FCC part 15 subpart B / Class A

Power: 120V/60Hz

Tested Line: Phase

Operating Mode:

Comments:

TEST PARAMETERSFrequency Range
150 kHz - 30 MHzBandwidth
9 kHz**TEST EQUIPMENT USED**LF#1+LF#2
LISN : PMM L2-16B#20801-red
Rohde & Schwarz : ESW44**FINAL RESULTS - QUASI-PEAK**

Frequency	SR #	Quasi-Peak Detector (dB μ V)	Quasi-Peak Limit (dB μ V)	Margin (dB)	Correction (dB)
434.907 kHz	1	48.628	79	30.372	0.133
468.933 kHz	1	48.747	79	30.253	0.134
4.840952 MHz	1	39.71	73	33.29	0.215
6.13956 MHz	1	36.751	73	36.249	0.248
7.282049 MHz	1	36.323	73	36.677	0.284
17.716113 MHz	1	29.817	73	43.183	0.61

FINAL RESULTS - AVERAGE

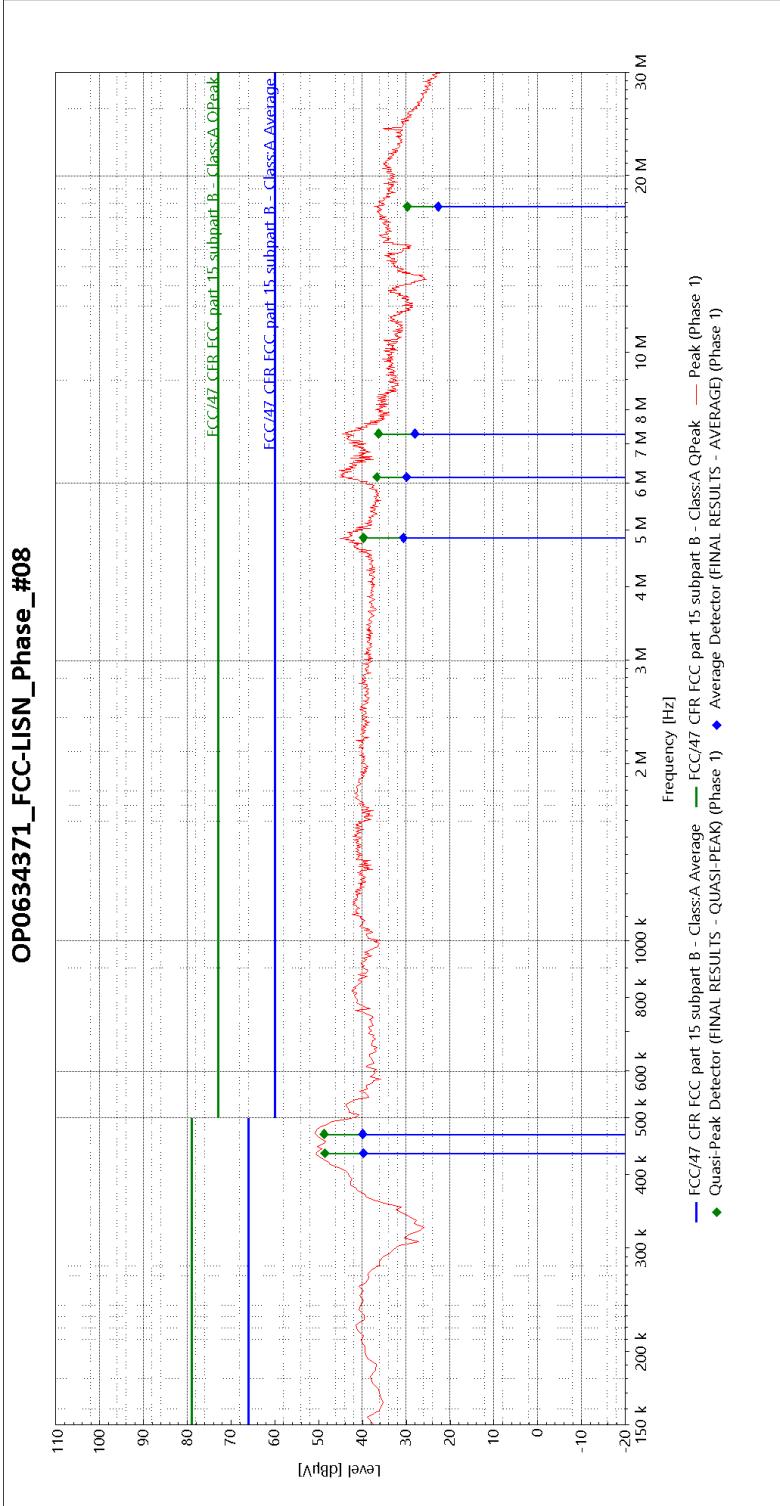
Frequency	SR #	Average Detector (dB μ V)	Average Limit (dB μ V)	Margin (dB)	Correction (dB)
434.907 kHz	1	39.825	66	26.175	0.133
468.933 kHz	1	40.014	66	25.986	0.134
4.840952 MHz	1	30.709	60	29.291	0.215
6.13956 MHz	1	29.907	60	30.093	0.248
7.282049 MHz	1	28.094	60	31.906	0.284
17.716113 MHz	1	22.762	60	37.238	0.61



CONDUCTED EMISSIONS - VOLTAGE
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OP0634371_FCC-LISN_Phase_#08



— FCC/47 CFR FCC part 15 subpart B - Class A Average
— FCC/47 CFR FCC part 15 subpart B - Class A QPeak
◆ Quasi-Peak Detector (FINAL RESULTS - QUASI-PEAK) (Phase 1)
◆ Average Detector (FINAL RESULTS - AVERAGE) (Phase 1)


CONDUCTED EMISSIONS - VOLTAGE
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Project: OP0634371**Customer:** Inogeni**DESCRIPTION OF EQUIPMENT UNDER TEST (EUT)**

Equipment: CAM230

Manufacturer: Inogeni

Hardware Version:

Software Version:

CONDUCTED EMISSIONS MEASUREMENT: OP0634371_FCC-LISN_Neutral_#09

Test Location: Anechoic chamber

Test Date: 2023-04-05 2:02:06 PM

Operator(s): Jean Cadotte

Test Standard: FCC part 15 subpart B / Class A

Power: 120V/60Hz

Tested Line: Neutral

Operating Mode:

Comments:

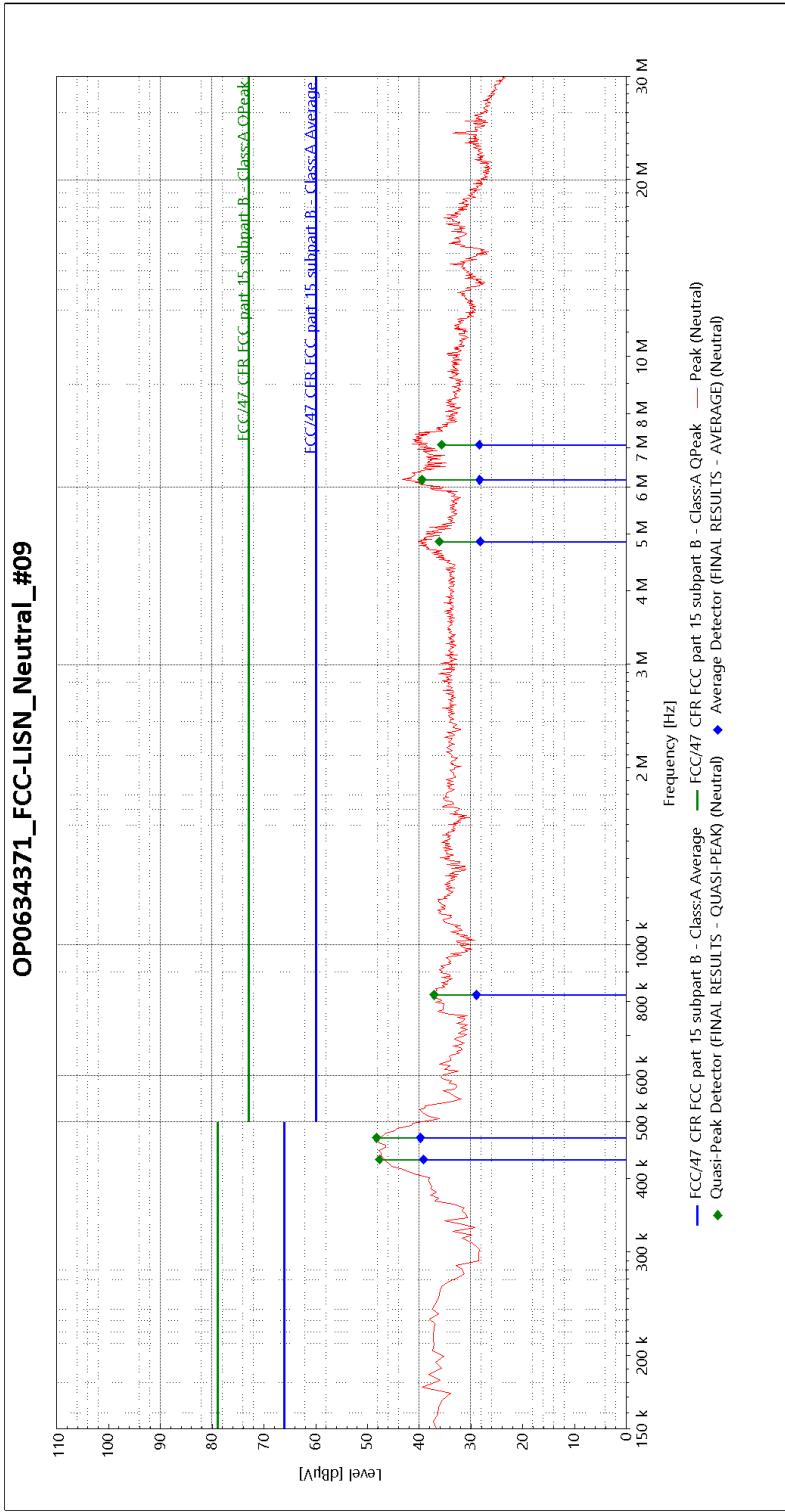
TEST PARAMETERS**TEST EQUIPMENT USED**Frequency Range
150 kHz - 30 MHzBandwidth
9 kHzLF#1+LF#2
LISN : PMM L2-16B#20801-red
Rohde & Schwarz : ESW44**FINAL RESULTS - QUASI-PEAK**

Frequency	SR #	Quasi-Peak Detector (dB μ V)	Quasi-Peak Limit (dB μ V)	Margin (dB)	Correction (dB)
431.476 kHz	1	47.729	79	31.271	0.333
469.137 kHz	1	48.243	79	30.757	0.344
821.088 kHz	1	37.128	73	35.872	0.357
4.846234 MHz	1	36.135	73	36.865	0.465
6.172935 MHz	1	39.499	73	33.501	0.501
7.083614 MHz	1	35.733	73	37.267	0.53

FINAL RESULTS - AVERAGE

Frequency	SR #	Average Detector (dB μ V)	Average Limit (dB μ V)	Margin (dB)	Correction (dB)
431.476 kHz	1	39.227	66	26.773	0.333
469.137 kHz	1	39.803	66	26.197	0.344
821.088 kHz	1	28.985	60	31.015	0.357
4.846234 MHz	1	28.191	60	31.809	0.465
6.172935 MHz	1	28.314	60	31.686	0.501
7.083614 MHz	1	28.431	60	31.569	0.53

CONDUCTED EMISSIONS - VOLTAGE
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CONDUCTED EMISSIONS - VOLTAGE
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Project: OP0634371

Customer: Inogeni

DESCRIPTION OF EQUIPMENT UNDER TEST (EUT)

Equipment: CAM230

Manufacturer: Inogeni

Hardware Version:

Software Version:

CONDUCTED EMISSIONS MEASUREMENT: OP0634371_EN55032-ISN_#12

Test Location: Anechoic chamber

Test Date: 2023-04-05 2:54:51 PM

Operator(s): Xavier Couste

Test Standard: EN55032 Class A

Power: 230V/50Hz

Tested Line: Ethernet

Operating Mode: 5%

Comments:

TEST PARAMETERS

TEST EQUIPMENT USED

Frequency Range
150 kHz - 30 MHzBandwidth
9 kHzISN : ST08A
LF#1+LF#2

Rohde & Schwarz : ESW44

FINAL RESULTS - QUASI-PEAK

Frequency	SR #	Quasi-Peak Detector (dB μ V)	Quasi-Peak Limit (dB μ V)	Margin (dB)	Correction (dB)
271.5 kHz	1	61.334	92.072	30.738	9.712
537.676 kHz	1	63.426	87	23.574	9.687
2.895175 MHz	1	66.231	87	20.769	9.676
4.800932 MHz	1	71.239	87	15.761	9.73
6.276056 MHz	1	68.947	87	18.053	9.779
7.220632 MHz	1	66.648	87	20.352	9.821

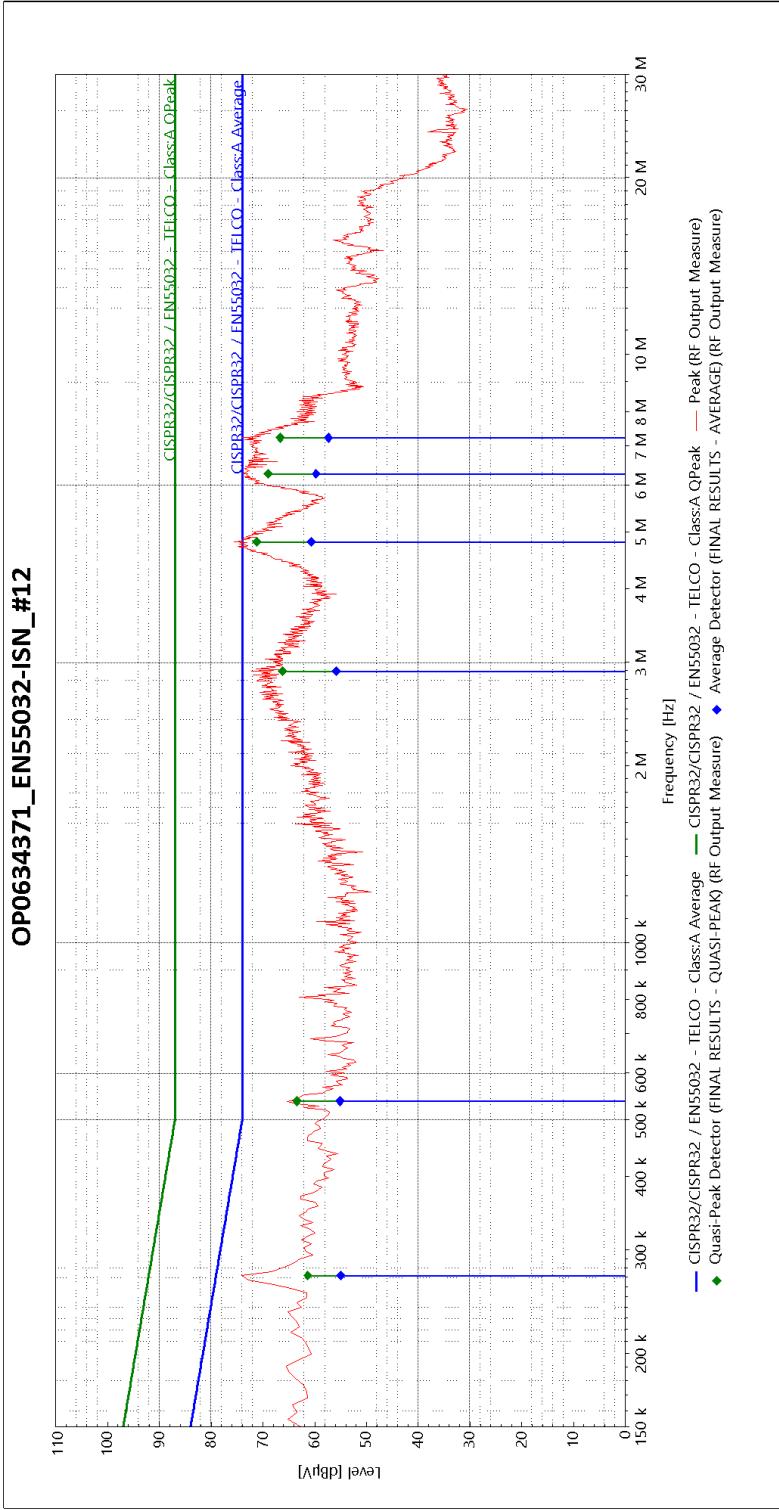
FINAL RESULTS - AVERAGE

Frequency	SR #	Average Detector (dB μ V)	Average Limit (dB μ V)	Margin (dB)	Correction (dB)
271.5 kHz	1	54.922	79.072	24.15	9.712
537.676 kHz	1	55.127	74	18.873	9.687
2.895175 MHz	1	55.842	74	18.158	9.676
4.800932 MHz	1	60.625	74	13.375	9.73
6.276056 MHz	1	59.717	74	14.283	9.779
7.220632 MHz	1	57.359	74	16.641	9.821

CONDUCTED EMISSIONS - VOLTAGE
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OP0634371_EN55032-ISM_#12



- CISPR32/CISPR32 - EN55032 - TELCO - CLASS A Peak — Peak (RF Output Measure)
- ◆ Quasi-Peak Detector (FINAL RESULTS - QUASI-PEAK) (RF Output Measure) ◆ Average Detector (FINAL RESULTS - AVERAGE) (RF Output Measure)

**APPENDIX B
RADIATED EMISSIONS**



RADIATED EMISSIONS – ELECTRIC FIELD
page 1 / 2

Project: OP0634371

Customer: Inogeni

DESCRIPTION OF EQUIPMENT UNDER TEST (EUT)

Equipment: CAM230
Manufacturer: Inogeni
Hardware Version:
Software Version:

RADIATED EMISSIONS MEASUREMENT: OP0634371_EN55032_FCC-Bilog_#05

Test Location: Anechoic chamber
Test Date: 2023-04-05 10:37:31 AM
Operator(s): Jean Cadotte
Test Standard: EN55032 / FCC part 15 subpart B / Class A
Power: 230V/50Hz
Operating Mode:
Comments:

TEST PARAMETERS

Frequency Range 30 MHz - 1 GHz	Bandwidth 120 kHz	Test Distance 3 m
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TEST EQUIPMENT USED

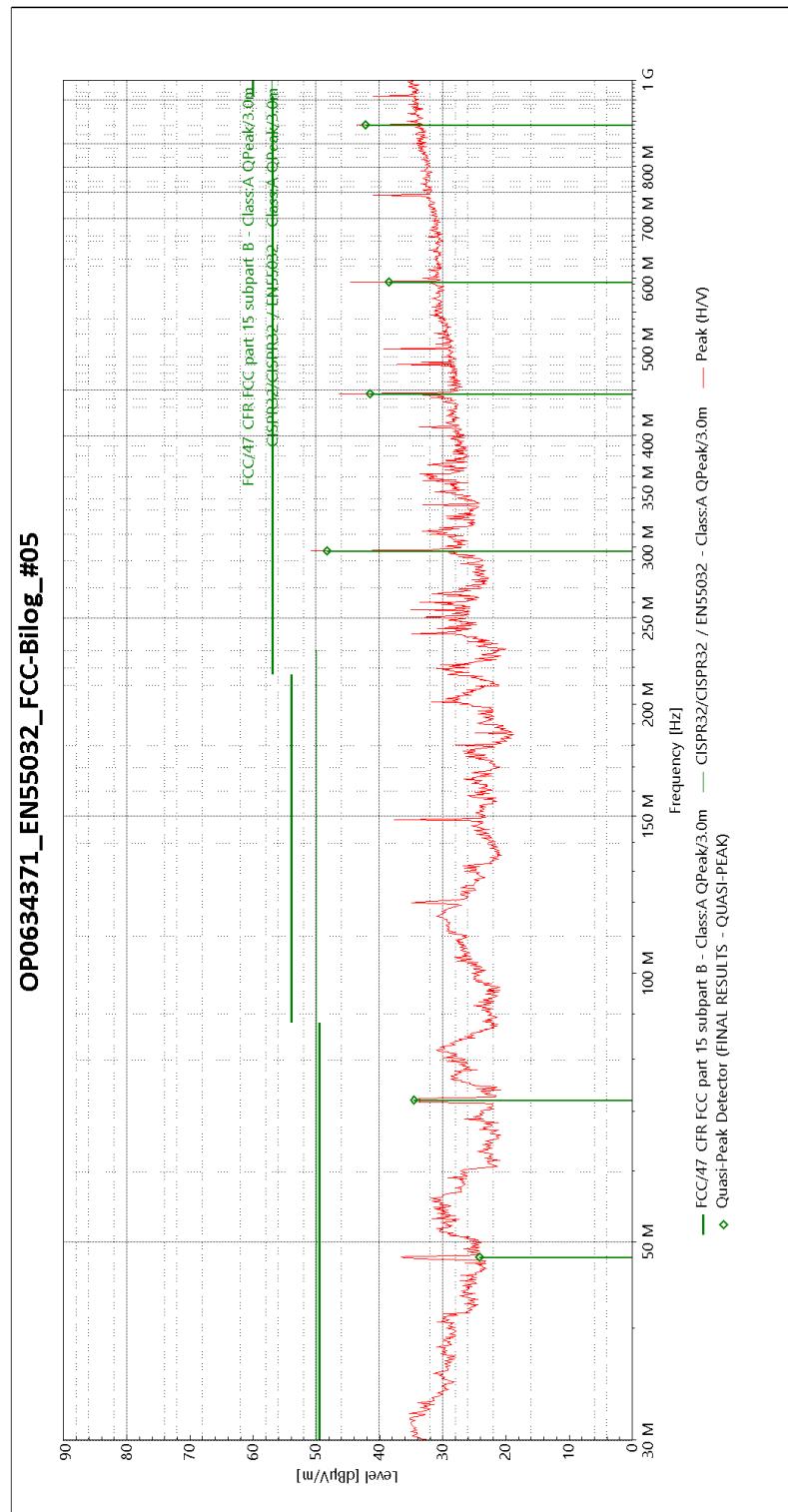
Antenna Mast : SUNOL
Bilog Antenna + 6dB : Schaffner CBL6112D#22617
HF#1 + HF#2
Rohde & Schwarz : ESW44
Turntable : SUNOL

FINAL RESULTS - QUASI-PEAK

Frequency	SR #	Quasi-Peak Detector (dB μ V/m)	Quasi-Peak Limit (dB μ V/m)	Margin (dB)	Polarization	Azimuth (degree)	Height (m)	Correction (dB)
48.042 MHz	1	24.177	50	25.823	Vertical	22.5	1.109	15.399
72.103676 MHz	1	34.519	50	15.481	Vertical	360	1.226	13.2
297.013534 MHz	1	48.337	57	8.663	Horizontal	143	1.109	20.77
445.521297 MHz	1	41.48	57	15.52	Horizontal	304.25	1	24.635
594.028297 MHz	1	38.504	57	18.496	Vertical	147.25	1	27.1
891.012542 MHz	1	42.262	57	14.738	Horizontal	296.5	1	29.59



RADIATED EMISSIONS – ELECTRIC FIELD
page 2 / 2




RADIATED EMISSIONS – ELECTRIC FIELD
 page 1 / 2
Project: OP0634371**Customer:** Inogeni**DESCRIPTION OF EQUIPMENT UNDER TEST (EUT)**

Equipment: CAM230
 Manufacturer: Inogeni
 Hardware Version:
 Software Version:

RADIATED EMISSIONS MEASUREMENT: OP0634371_EN55032_FCC-Horn_#06

Test Location: Anechoic chamber
 Test Date: 2023-04-05 12:05:14 PM
 Operator(s): Xavier Couste
 Test Standard: EN55032 / FCC part 15 subpart B / Class A
 Power: 230V/50Hz
 Operating Mode:
 Comments:

TEST PARAMETERS

Frequency Range	Bandwidth	Test Distance
1 GHz - 3.6 GHz	1 MHz	3 m
3.6 GHz - 6 GHz	1 MHz	3 m

TEST EQUIPMENT USED

Antenna Mast : SUNOL
 HF#1+HF#2 + HF-LNA + 3dB
 Horn Antenna : TESEQ BHA9118
 Rohde & Schwarz : ESW44
 Turntable : SUNOL

FINAL RESULTS - PEAK

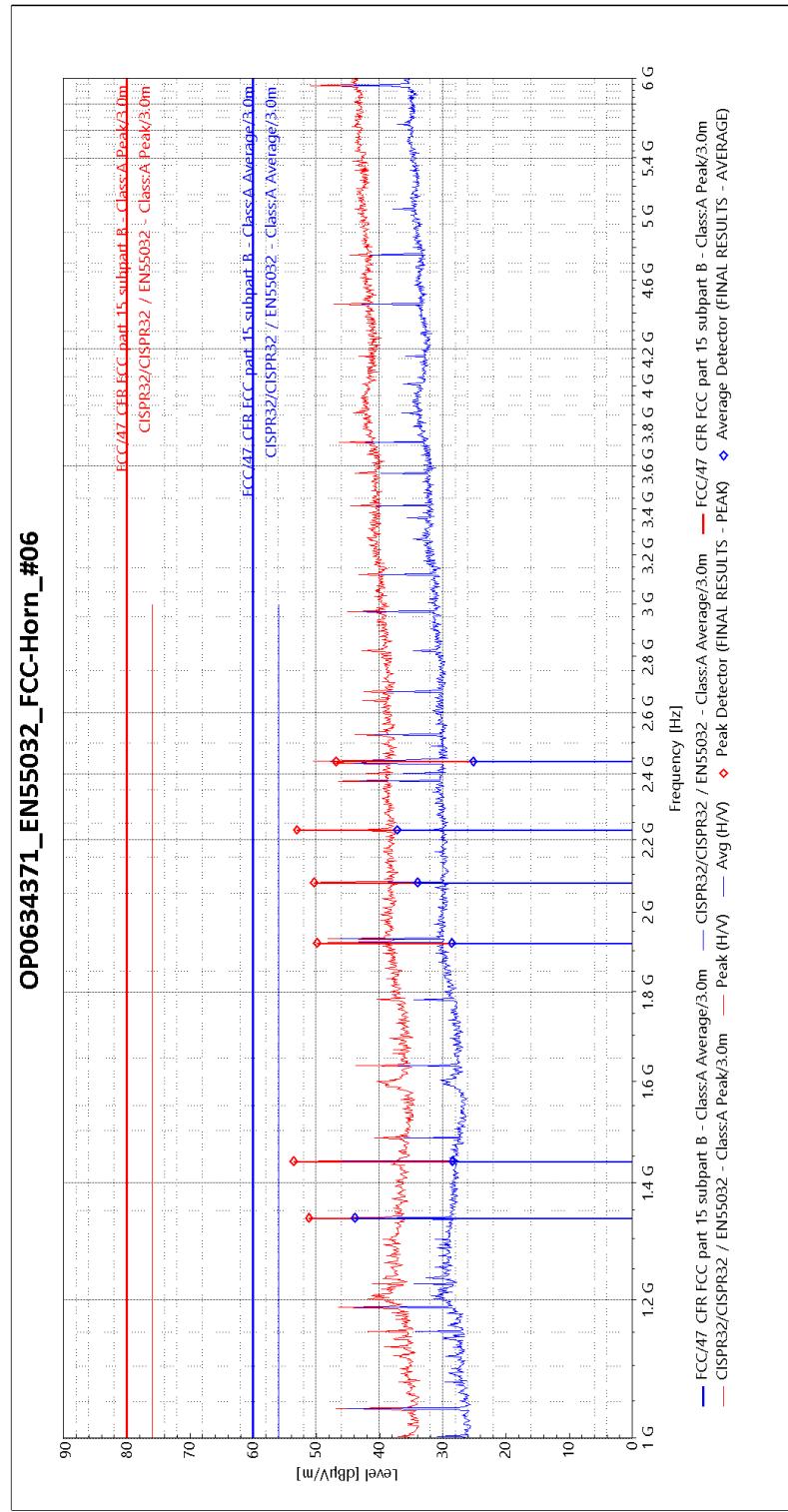
Frequency	SR #	Peak Detector (dB μ V/m)	Peak Limit (dB μ V/m)	Margin (dB)	Polarization	Azimuth (degree)	Height (m)	Correction (dB)
1.33656207 GHz	1	51.144	76	24.856	Vertical	285.25	3.172	-13.27
1.440019182 GHz	1	53.626	76	22.374	Horizontal	2.75	1.1	-13.361
1.920027084 GHz	1	49.854	76	26.146	Vertical	230.25	3.943	-10.651
2.079100107 GHz	1	50.319	76	25.681	Horizontal	28.5	1.022	-9.865
2.227607084 GHz	1	53.05	76	22.95	Vertical	282.75	3.882	-9.706
2.438287031 GHz	1	46.87	76	29.13	Horizontal	197.5	1.388	-8.866

FINAL RESULTS - AVERAGE

Frequency	SR #	Average Detector (dB μ V/m)	Average Limit (dB μ V/m)	Margin (dB)	Polarization	Azimuth (degree)	Height (m)	Correction (dB)
1.33656207 GHz	1	43.929	56	12.071	Vertical	285.25	3.172	-13.27
1.440019182 GHz	1	28.426	56	27.574	Horizontal	2.75	1.1	-13.361
1.920027084 GHz	1	28.55	56	27.45	Vertical	230.25	3.943	-10.651
2.079100107 GHz	1	33.935	56	22.065	Horizontal	28.5	1.022	-9.865
2.227607084 GHz	1	37.158	56	18.842	Vertical	282.75	3.882	-9.706
2.438287031 GHz	1	25.186	56	30.814	Horizontal	197.5	1.388	-8.866



RADIATED EMISSIONS – ELECTRIC FIELD
page 2 / 2



PR / OP0634371_EN55032_FCC-Horn_#06.docx





RADIATED EMISSIONS – ELECTRIC FIELD
page 1 / 2

Project: OP0634371

Customer: Inogeni

DESCRIPTION OF EQUIPMENT UNDER TEST (EUT)

Equipment: CAM230
Manufacturer: Inogeni
Hardware Version:
Software Version:

RADIATED EMISSIONS MEASUREMENT: OP0634371_ICES-003_FCC-Horn_#07

Test Location: Anechoic chamber
Test Date: 2023-04-05 11:42:50 AM
Operator(s): Jean Cadotte
Test Standard: FCC part 15 subpart B / Class A
Power: 230V/50Hz
Operating Mode:
Comments:

TEST PARAMETERS

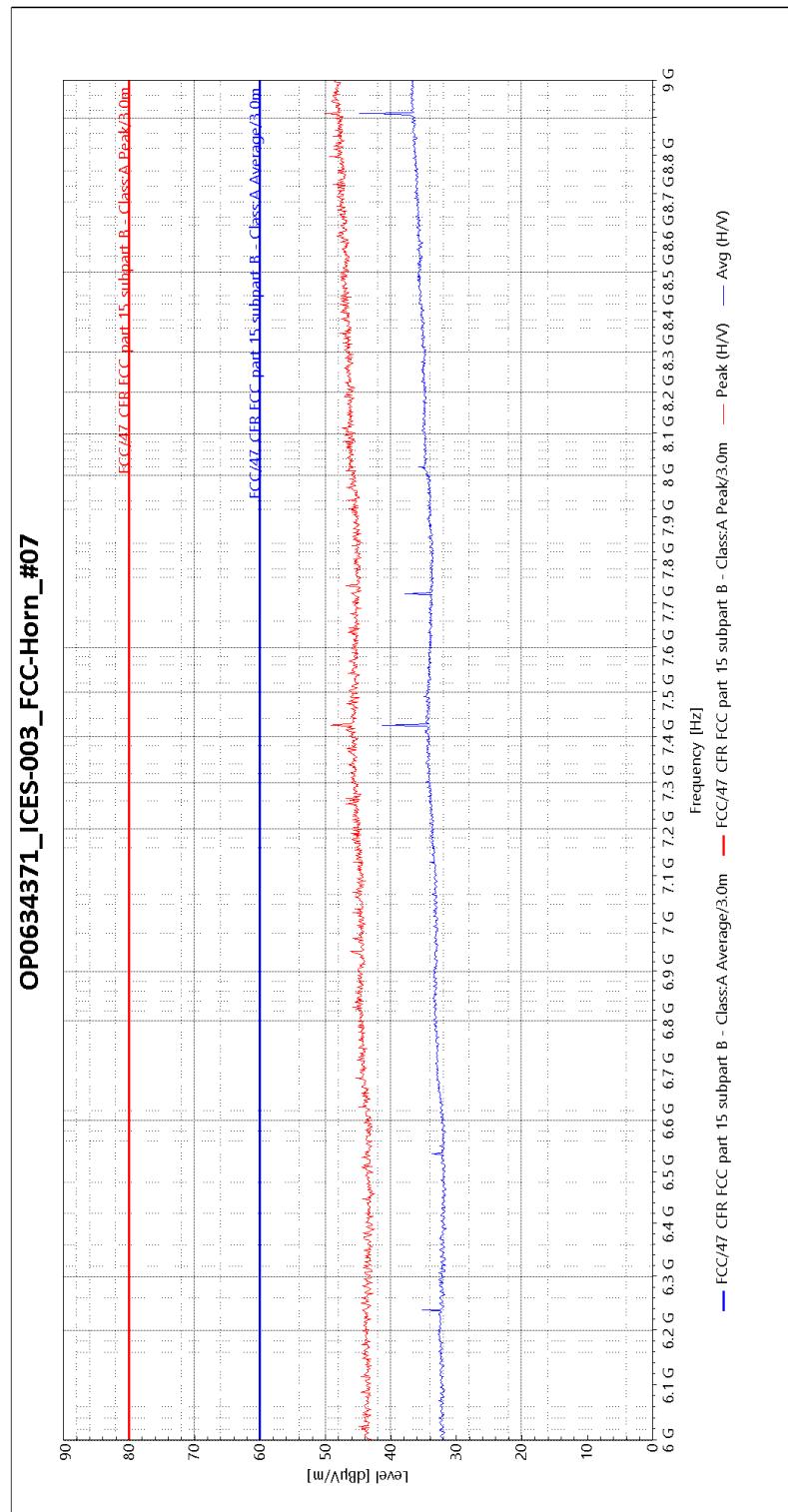
Frequency Range 6 GHz - 9 GHz	Bandwidth 1 MHz	Test Distance 3 m
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TEST EQUIPMENT USED

Antenna Mast : SUNOL
HF#1+HF#2 + HF-LNA + 3dB
Horn Antenna : TESEQ BHA9118
Rohde & Schwarz : ESW44
Turntable : SUNOL



RADIATED EMISSIONS – ELECTRIC FIELD
page 2 / 2



APPENDIX C
HARMONIC CURRENT EMISSIONS LIMITS

Teseq Profline
4542 Luterbach, Switzerland

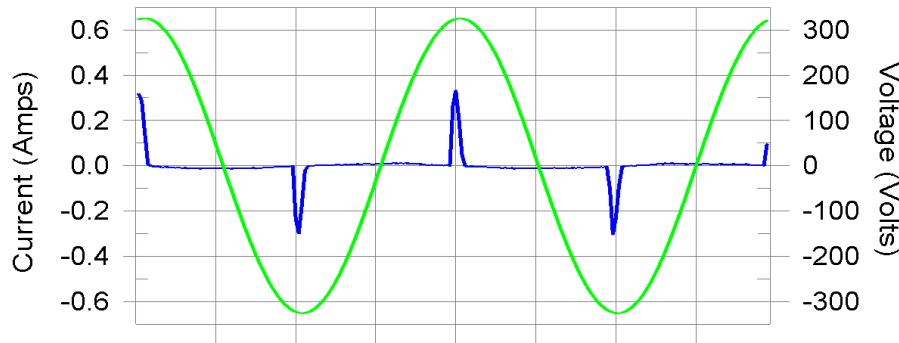
4/11/2023
8:01 AM

Harmonics – Class-A per Ed. 4.0 (2014)(Run time)

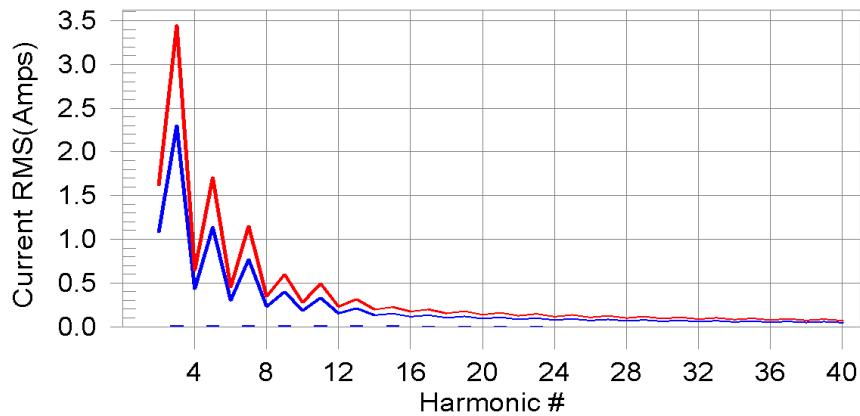
EUT: CAM230
Test category: Class-A per Ed. 4.0 (2014) (European limits)
Test date: 4/6/2023 Start time: 4:50:25 PM End time: 4:52:46 PM
Test duration (min): 2 Data file name: H-000196.cts_data
Comment: Harmonics Measurements
Customer: Inogeni

Test Result: Pass Source qualification: Normal

Current & voltage waveforms



Harmonics and Class A limit line European Limits



Test result: Pass Worst harmonic was #19 with 6.8% of the limit.

Teseq Profline
4542 Luterbach, Switzerland

4/11/2023
8:01 AM

Current Test Result Summary (Run time)

EUT: CAM230 Tested by: Jean Cadotte
 Test category: Class-A per Ed. 4.0 (2014) (European limits) Test Margin: 100
 Test date: 4/6/2023 Start time: 4:50:25 PM End time: 4:52:46 PM
 Test duration (min): 2 Data file name: H-000196.cts_data
 Comment: Harmonics Measurements
 Customer: Inogeni

Test Result: Pass Source qualification: Normal
 THC(A): 0.054 I-THD(%): 243.5 POHC(A): 0.018 POHC Limit(A): 0.251

Highest parameter values during test:

V_RMS (Volts):	230.51	Frequency(Hz):	50.00
I_Peak (Amps):	0.350	I_RMS (Amps):	0.061
I_Fund (Amps):	0.022	Crest Factor:	5.922
Power (Watts):	4.8	Power Factor:	0.351

Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.001	1.080	N/A	0.001	1.620	N/A	Pass
3	0.020	2.300	0.9	0.020	3.450	0.6	Pass
4	0.001	0.430	N/A	0.001	0.645	N/A	Pass
5	0.020	1.140	1.7	0.020	1.710	1.2	Pass
6	0.001	0.300	N/A	0.001	0.450	N/A	Pass
7	0.019	0.770	2.5	0.019	1.155	1.6	Pass
8	0.000	0.230	N/A	0.001	0.345	N/A	Pass
9	0.018	0.400	4.5	0.018	0.600	3.0	Pass
10	0.000	0.184	N/A	0.001	0.276	N/A	Pass
11	0.017	0.330	5.2	0.017	0.495	3.5	Pass
12	0.000	0.153	N/A	0.001	0.230	N/A	Pass
13	0.016	0.210	7.6	0.016	0.315	5.1	Pass
14	0.000	0.131	N/A	0.001	0.197	N/A	Pass
15	0.015	0.150	9.8	0.015	0.225	6.6	Pass
16	0.000	0.115	N/A	0.001	0.173	N/A	Pass
17	0.013	0.132	10.2	0.014	0.198	6.8	Pass
18	0.000	0.102	N/A	0.001	0.153	N/A	Pass
19	0.012	0.118	10.2	0.012	0.178	6.8	Pass
20	0.000	0.092	N/A	0.001	0.138	N/A	Pass
21	0.011	0.107	10.0	0.011	0.161	6.7	Pass
22	0.000	0.084	N/A	0.001	0.125	N/A	Pass
23	0.009	0.098	9.6	0.009	0.147	6.4	Pass
24	0.000	0.077	N/A	0.001	0.115	N/A	Pass
25	0.008	0.090	8.9	0.008	0.135	5.9	Pass
26	0.000	0.071	N/A	0.001	0.107	N/A	Pass
27	0.007	0.083	8.1	0.007	0.125	5.4	Pass
28	0.000	0.066	N/A	0.001	0.099	N/A	Pass
29	0.006	0.078	7.1	0.006	0.116	4.8	Pass
30	0.000	0.061	N/A	0.001	0.092	N/A	Pass
31	0.004	0.073	N/A	0.004	0.109	N/A	Pass
32	0.000	0.058	N/A	0.001	0.086	N/A	Pass
33	0.004	0.068	N/A	0.004	0.102	N/A	Pass
34	0.000	0.054	N/A	0.001	0.081	N/A	Pass
35	0.003	0.064	N/A	0.003	0.096	N/A	Pass
36	0.000	0.051	N/A	0.000	0.077	N/A	Pass
37	0.002	0.061	N/A	0.002	0.091	N/A	Pass
38	0.000	0.048	N/A	0.000	0.073	N/A	Pass
39	0.002	0.058	N/A	0.002	0.087	N/A	Pass
40	0.000	0.046	N/A	0.000	0.069	N/A	Pass

Teseq Profline
4542 Luterbach, Switzerland

4/11/2023
8:01 AM

Voltage Source Verification Data (Run time)

EUT: CAM230
 Test category: Class-A per Ed. 4.0 (2014) (European limits)
 Test date: 4/6/2023 Start time: 4:50:25 PM End time: 4:52:46 PM
 Test duration (min): 2 Data file name: H-000196.cts_data
 Comment: Harmonics Measurements
 Customer: Inogeni

Test Result: Pass Source qualification: Normal

Highest parameter values during test:

Voltage (Vrms):	230.51	Frequency(Hz):	50.00
I_Peak (Amps):	0.350	I_RMS (Amps):	0.061
I_Fund (Amps):	0.022	Crest Factor:	5.922
Power (Watts):	4.8	Power Factor:	0.351

Harm#	Harmonics V-rms	Limit V-rms	% of Limit	Status
2	0.030	0.461	6.43	OK
3	0.408	2.074	19.69	OK
4	0.025	0.461	5.50	OK
5	0.035	0.922	3.77	OK
6	0.025	0.461	5.47	OK
7	0.021	0.691	3.04	OK
8	0.007	0.461	1.43	OK
9	0.023	0.461	5.05	OK
10	0.006	0.461	1.35	OK
11	0.011	0.230	4.98	OK
12	0.012	0.230	5.32	OK
13	0.014	0.230	5.86	OK
14	0.004	0.230	1.73	OK
15	0.007	0.230	2.85	OK
16	0.011	0.230	4.76	OK
17	0.012	0.230	5.02	OK
18	0.014	0.230	6.08	OK
19	0.013	0.230	5.49	OK
20	0.014	0.231	6.27	OK
21	0.014	0.230	5.92	OK
22	0.004	0.230	1.68	OK
23	0.011	0.230	4.64	OK
24	0.004	0.230	1.60	OK
25	0.010	0.230	4.38	OK
26	0.002	0.230	0.97	OK
27	0.004	0.230	1.58	OK
28	0.002	0.230	0.84	OK
29	0.012	0.230	5.12	OK
30	0.003	0.230	1.12	OK
31	0.007	0.230	3.22	OK
32	0.002	0.230	0.71	OK
33	0.005	0.230	2.38	OK
34	0.001	0.230	0.62	OK
35	0.006	0.230	2.58	OK
36	0.002	0.230	0.74	OK
37	0.005	0.230	2.20	OK
38	0.002	0.230	0.84	OK
39	0.003	0.230	1.44	OK
40	0.005	0.230	2.01	OK

Teseq Profline
4542 Luterbach, Switzerland

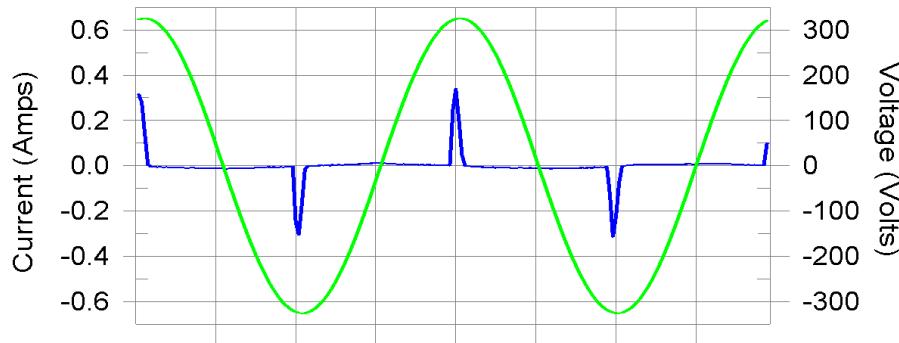
4/11/2023
8:02 AM

Harmonics – Class-A per Ed. 4.0 (2014)(Run time)

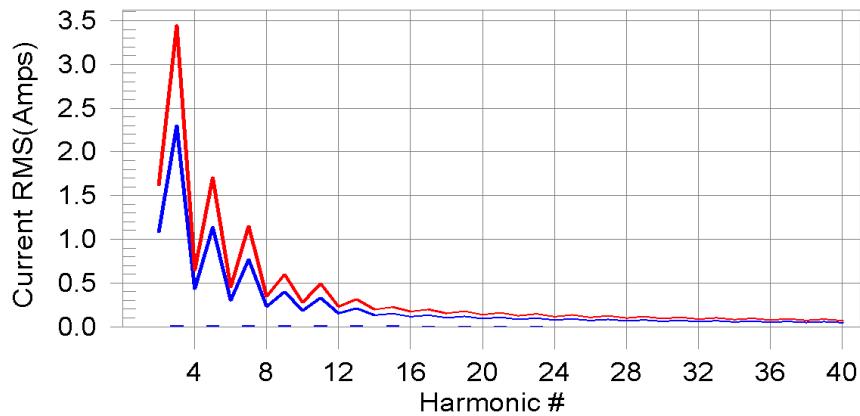
EUT: CAM230
Test category: Class-A per Ed. 4.0 (2014) (European limits)
Test date: 4/6/2023 Start time: 4:55:22 PM End time: 4:57:44 PM
Test duration (min): 2 Data file name: H-000197.cts_data
Comment: Harmonics Measurements
Customer: Inogeni

Test Result: Pass Source qualification: Normal

Current & voltage waveforms



Harmonics and Class A limit line European Limits



Test result: Pass Worst harmonic was #19 with 6.9% of the limit.

Teseq Profline
4542 Luterbach, Switzerland

4/11/2023
8:02 AM

Current Test Result Summary (Run time)

EUT: CAM230 Tested by: Jean Cadotte
 Test category: Class-A per Ed. 4.0 (2014) (European limits) Test Margin: 100
 Test date: 4/6/2023 Start time: 4:55:22 PM End time: 4:57:44 PM
 Test duration (min): 2 Data file name: H-000197.cts_data
 Comment: Harmonics Measurements
 Customer: Inogeni

Test Result: Pass Source qualification: Normal
 THC(A): 0.054 I-THD(%): 243.9 POHC(A): 0.019 POHC Limit(A): 0.251

Highest parameter values during test:

V_RMS (Volts):	230.51	Frequency(Hz):	50.00
I_Peak (Amps):	0.357	I_RMS (Amps):	0.061
I_Fund (Amps):	0.023	Crest Factor:	5.965
Power (Watts):	4.8	Power Factor:	0.350

Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.001	1.080	N/A	0.001	1.620	N/A	Pass
3	0.020	2.300	0.9	0.020	3.450	0.6	Pass
4	0.001	0.430	N/A	0.001	0.645	N/A	Pass
5	0.020	1.140	1.7	0.020	1.710	1.2	Pass
6	0.001	0.300	N/A	0.001	0.450	N/A	Pass
7	0.019	0.770	2.4	0.019	1.155	1.7	Pass
8	0.000	0.230	N/A	0.001	0.345	N/A	Pass
9	0.018	0.400	4.5	0.018	0.600	3.1	Pass
10	0.000	0.184	N/A	0.001	0.276	N/A	Pass
11	0.017	0.330	5.2	0.017	0.495	3.5	Pass
12	0.000	0.153	N/A	0.001	0.230	N/A	Pass
13	0.016	0.210	7.6	0.016	0.315	5.2	Pass
14	0.000	0.131	N/A	0.001	0.197	N/A	Pass
15	0.015	0.150	9.8	0.015	0.225	6.7	Pass
16	0.000	0.115	N/A	0.001	0.173	N/A	Pass
17	0.013	0.132	10.2	0.014	0.198	6.9	Pass
18	0.000	0.102	N/A	0.001	0.153	N/A	Pass
19	0.012	0.118	10.2	0.012	0.178	6.9	Pass
20	0.000	0.092	N/A	0.001	0.138	N/A	Pass
21	0.011	0.107	10.0	0.011	0.161	6.8	Pass
22	0.000	0.084	N/A	0.001	0.125	N/A	Pass
23	0.009	0.098	9.6	0.009	0.147	6.4	Pass
24	0.000	0.077	N/A	0.001	0.115	N/A	Pass
25	0.008	0.090	8.9	0.008	0.135	6.0	Pass
26	0.000	0.071	N/A	0.001	0.107	N/A	Pass
27	0.007	0.083	8.1	0.007	0.125	5.4	Pass
28	0.000	0.066	N/A	0.000	0.099	N/A	Pass
29	0.006	0.078	7.2	0.006	0.116	4.8	Pass
30	0.000	0.061	N/A	0.000	0.092	N/A	Pass
31	0.004	0.073	N/A	0.005	0.109	N/A	Pass
32	0.000	0.058	N/A	0.000	0.086	N/A	Pass
33	0.004	0.068	N/A	0.004	0.102	N/A	Pass
34	0.000	0.054	N/A	0.000	0.081	N/A	Pass
35	0.003	0.064	N/A	0.003	0.096	N/A	Pass
36	0.000	0.051	N/A	0.000	0.077	N/A	Pass
37	0.002	0.061	N/A	0.002	0.091	N/A	Pass
38	0.000	0.048	N/A	0.000	0.073	N/A	Pass
39	0.002	0.058	N/A	0.002	0.087	N/A	Pass
40	0.000	0.046	N/A	0.000	0.069	N/A	Pass

Teseq Profline
4542 Luterbach, Switzerland

4/11/2023
8:02 AM

Voltage Source Verification Data (Run time)

EUT: CAM230
Test category: Class-A per Ed. 4.0 (2014) (European limits)
Test date: 4/6/2023 Start time: 4:55:22 PM End time: 4:57:44 PM
Test duration (min): 2 Data file name: H-000197.cts_data
Comment: Harmonics Measurements
Customer: Inogeni

Test Result: Pass Source qualification: Normal

Highest parameter values during test:

Voltage (Vrms):	230.51	Frequency(Hz):	50.00
I_Peak (Amps):	0.357	I_RMS (Amps):	0.061
I_Fund (Amps):	0.023	Crest Factor:	5.965
Power (Watts):	4.8	Power Factor:	0.350

Harm#	Harmonics V-rms	Limit V-rms	% of Limit	Status
2	0.030	0.461	6.47	OK
3	0.405	2.074	19.53	OK
4	0.024	0.461	5.14	OK
5	0.034	0.922	3.73	OK
6	0.024	0.461	5.19	OK
7	0.021	0.691	3.09	OK
8	0.007	0.461	1.46	OK
9	0.023	0.461	4.98	OK
10	0.006	0.461	1.32	OK
11	0.011	0.230	4.94	OK
12	0.012	0.230	5.25	OK
13	0.014	0.230	5.99	OK
14	0.004	0.230	1.71	OK
15	0.007	0.230	2.92	OK
16	0.011	0.230	4.68	OK
17	0.012	0.230	5.06	OK
18	0.013	0.230	5.67	OK
19	0.013	0.230	5.61	OK
20	0.014	0.230	6.04	OK
21	0.014	0.230	5.88	OK
22	0.003	0.230	1.52	OK
23	0.011	0.230	4.75	OK
24	0.004	0.230	1.63	OK
25	0.010	0.230	4.54	OK
26	0.003	0.230	1.23	OK
27	0.003	0.230	1.46	OK
28	0.002	0.230	0.81	OK
29	0.012	0.230	5.27	OK
30	0.004	0.230	1.53	OK
31	0.007	0.231	3.23	OK
32	0.002	0.230	0.79	OK
33	0.005	0.230	2.36	OK
34	0.002	0.230	0.81	OK
35	0.006	0.230	2.59	OK
36	0.002	0.230	0.88	OK
37	0.005	0.230	2.10	OK
38	0.002	0.230	0.87	OK
39	0.003	0.231	1.48	OK
40	0.005	0.230	2.07	OK

APPENDIX D
VOLTAGE FLUCTUATIONS AND FLICKER LIMITATIONS

Teseq Profline
4542 Luterbach, Switzerland

4/11/2023
8:03 AM

Flicker Test Summary per EN/IEC61000-3-3 Ed. 3.0 (2013) (Run time)

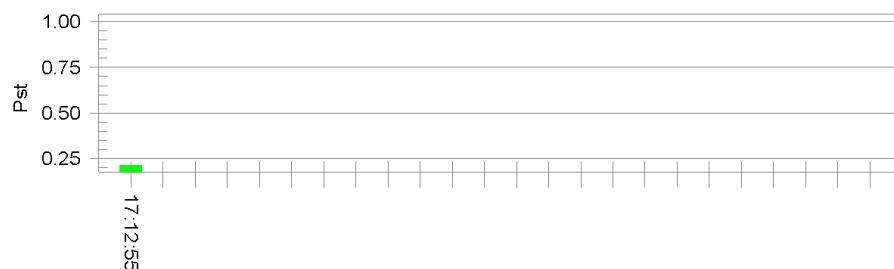
EUT: CAM230
Test category: All parameters (European limits)
Test date: 4/6/2023 Start time: 5:02:25 PM End time: 5:12:56 PM
Test duration (min): 10 Data file name: F-000198.cts_data
Comment: Flickers measurements
Customer: Inogeni

Test Result: Pass

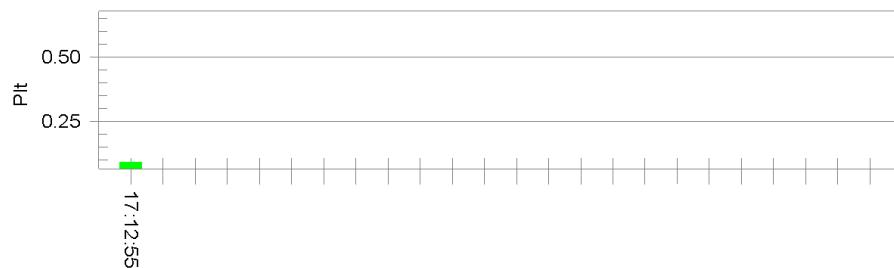
Status: Test Completed

Pst and limit line

European Limits



Plt and limit line



Parameter values recorded during the test:

Vrms at the end of test (Volt):	230.42	Test limit (%):	N/A	N/A
Highest dt (%):	0.00	Test limit (mS):	500.0	Pass
T-max (mS):	0	Test limit (%):	3.30	Pass
Highest dc (%):	0.00	Test limit (%):	4.00	Pass
Highest dmax (%):	0.03	Test limit (%):	1.000	Pass
Highest Pst (10 min. period):	0.218	Test limit:	0.650	Pass
Highest Plt (2 hr. period):	0.095			

Teseq Profline
4542 Luterbach, Switzerland

4/11/2023
8:03 AM

Flicker Test Summary per EN/IEC61000-3-3 Ed. 3.0 (2013) (Run time)

EUT: CAM230

Tested by: Jean Cadotte

Test category: All parameters (European limits)

Test Margin: 100

Test date: 4/10/2023

Start time: 8:57:13 AM

End time: 10:59:24 AM

Test duration (min): 120

Data file name: F-000199.cts_data

Comment: Flickers measurements Plt

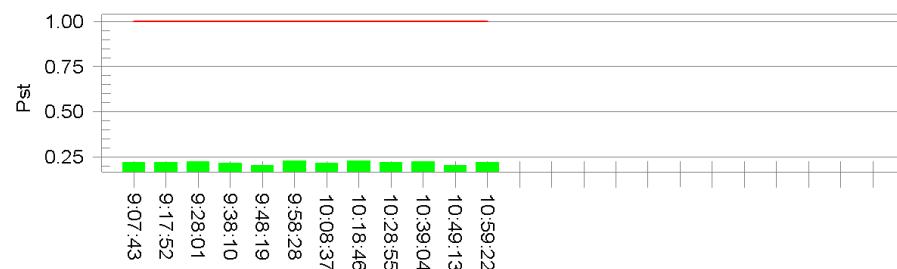
Customer: Inogeni

Test Result: Pass

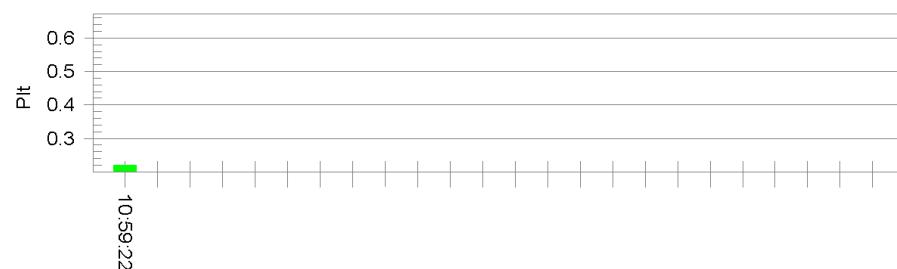
Status: Test Completed

Pst and limit line

European Limits



Plt and limit line



Parameter values recorded during the test:

Vrms at the end of test (Volt): 230.87

Highest dt (%):	0.00	Test limit (%):	N/A	N/A
T-max (mS):	0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.00	Test limit (%):	3.30	Pass
Highest dmax (%):	0.08	Test limit (%):	4.00	Pass
Highest Pst (10 min. period):	0.229	Test limit:	1.000	Pass
Highest Plt (2 hr. period):	0.222	Test limit:	0.650	Pass

END OF TEST REPORT